

Conquering Noise for Accurate RF and Microwave Signal Measurements

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Agilent Technologies



The Noise Presentation

- Review of Basics, Some Advanced & Newer Approaches
- Noise in Signal Measurements-Summary
- Basic Noise Reduction Approaches
- New Technologies
- Examples
- Resources, More Information



Noise is the Enemy

(Almost Always)

Communications, RADAR or other Imaging, Metrology, Science

- Creates Uncertainty in Time, Frequency, Power, Modulation
- Converts Deterministic Values to Statistical Distributions
- Imposes Cost Tradeoffs: Accuracy, Speed, Repeatability, Yield, €/£/¥/\$, “False Alarms”
- Financial Impacts: Circuit Cost, Size, Complexity, Development Time, Mfg.

Noise is the Enemy (cont)

- Phase Noise
 - Increases noise floor close-in
 - Creates same problems as broadband noise
 - Imposes similar tradeoffs, costs
- Solutions for Analysis are Similar
 - Optimize measurement technique
 - Choose a higher performance analyzer
 - Use special techniques, processing

Use “Moore’s Law” where it does not normally apply



Exceptions: Desirable Noise

- Noise Figure Measurements
- Accurately Generate to Test for Margins, Real World Performance
 - Generate known signal/noise, phase noise
- Broadband/Narrowband Noise as Stimulus Signal, with Different Statistics
- Add to Simulations to Avoid Non-Representative Behavior
- Noise Floor Appearance as a Clue or Hint



Noise Can Frequently be Ignored

But it is Important to be Alert

- Good Signal/Noise Ratio
- Measurement BW Wider than Signal
- Alert for Clues
 - Measurement variance large compared to desired accuracy
 - Measurements change with analyzer settings
 - Decreasing SNR
 - Comparing signals with different statistics

Optimize Noise vs. Other Measurement Priorities

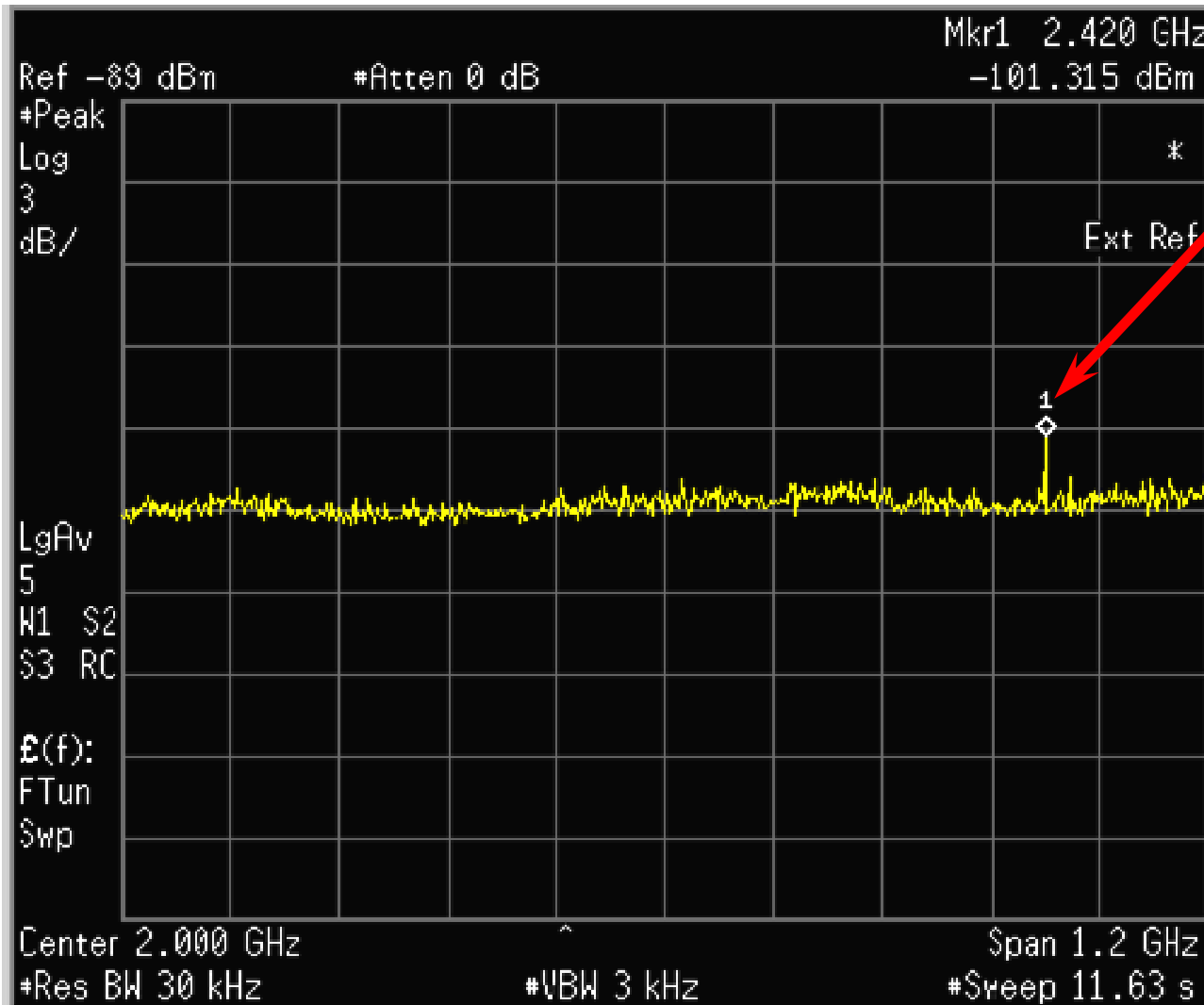
- Attenuation = 0 dB Optimal for Sensitivity
- Attenuation = 10+ dB for Optimal Accuracy
- Attenuation = 4-6 dB a Compromise
- Problems with Impedance Match
- Problems with Distortion, Compression
- Chance of Analyzer Input Damage



Trade Away Extra Noise Performance for other Benefits

- Better Overload Performance
- Lower Distortion Measurements
- Faster Measurements

Bad Measurements are Easy to Make



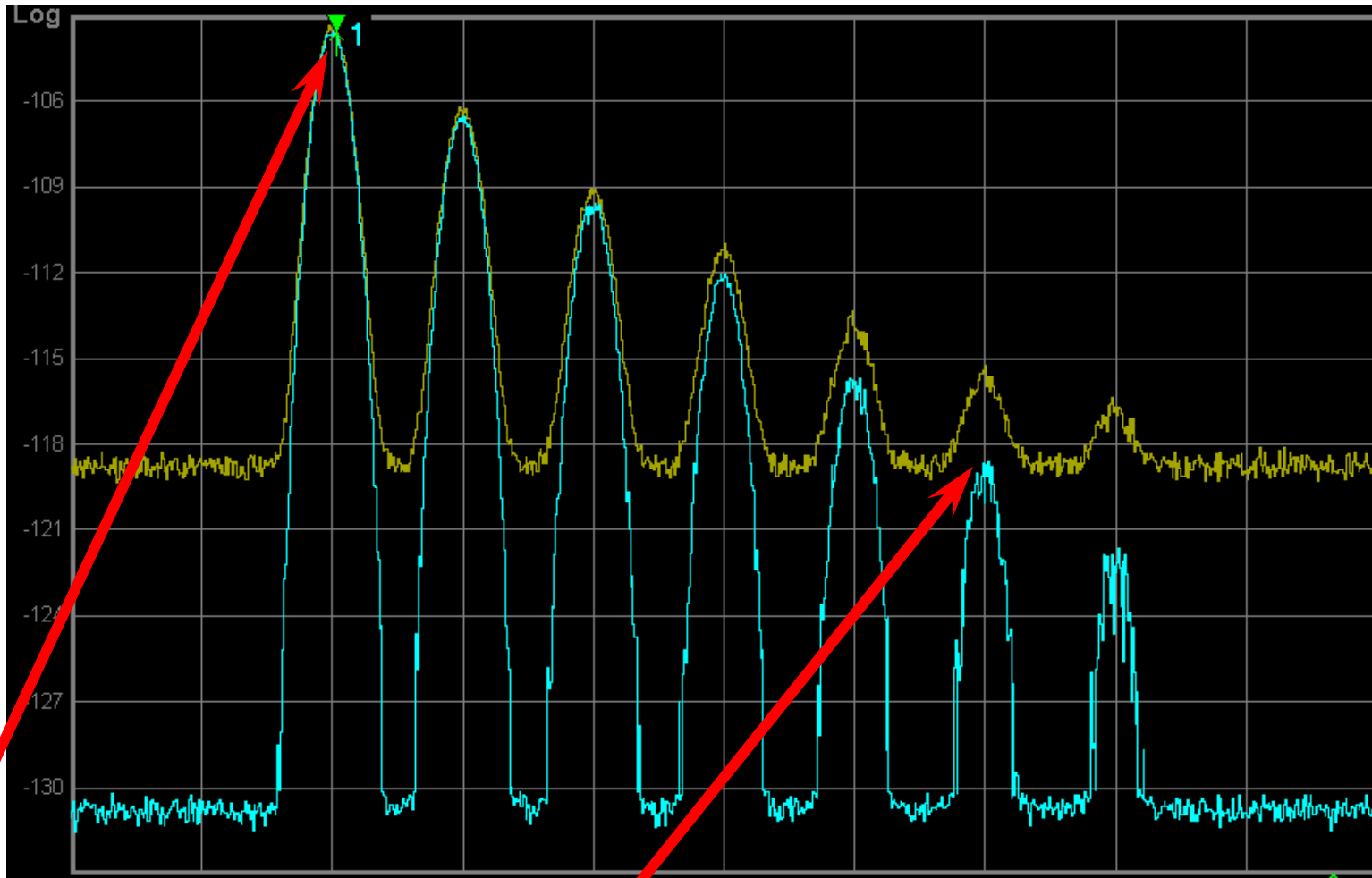
**Spur appears
3 dB above
noise level**

Error in Noise Level Measurements, Measured Near Analyzer Noise floor

Actual Noise Ratio	Measurement Error
0 dB	3.01 dB
1 dB	2.54 dB
3 dB	1.76 dB
5 dB	1.19 dB
10 dB	0.41 dB
15 dB	0.14 dB
20 dB	0.04 dB

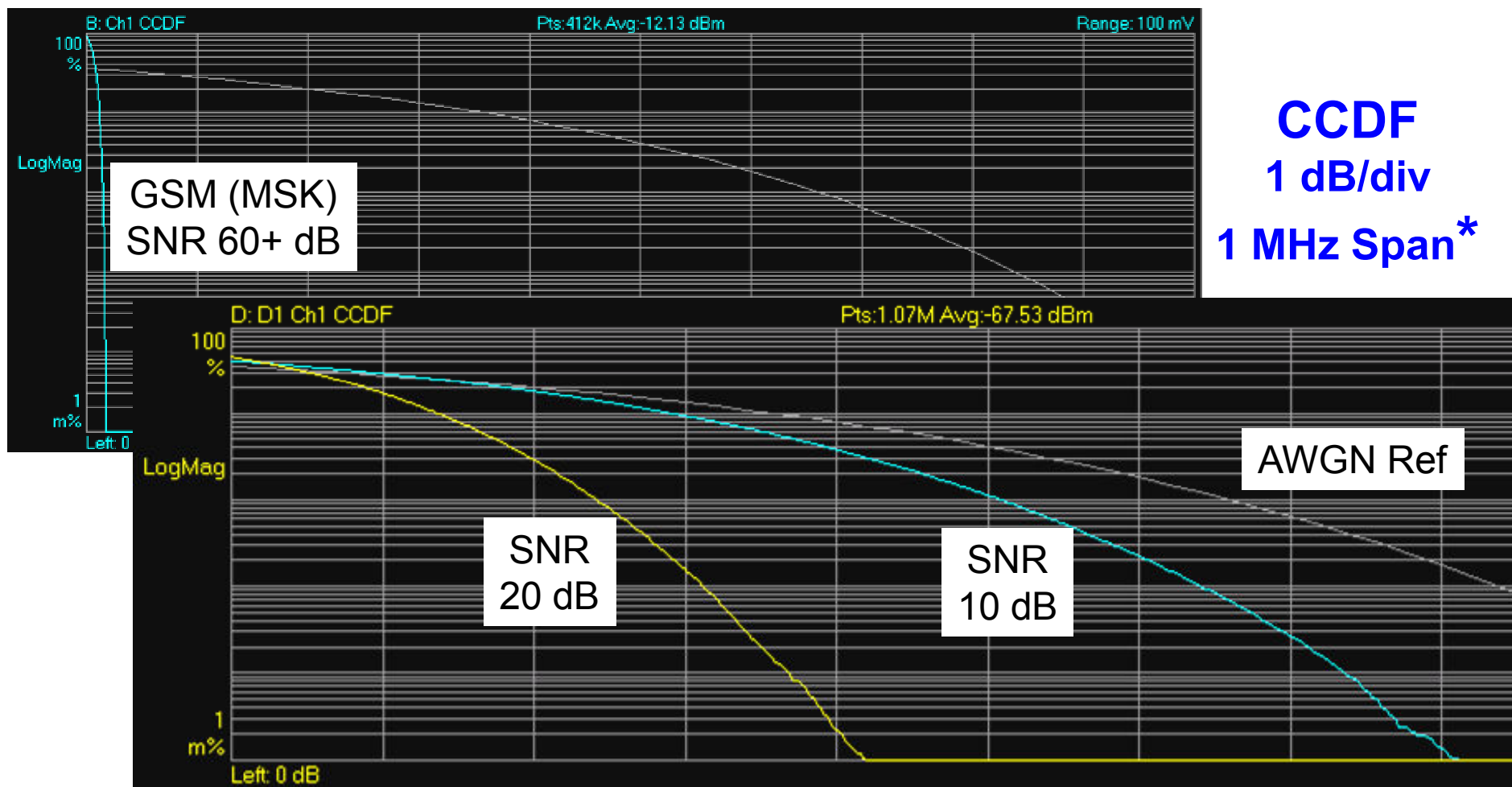
Note that error is always positive

Multiple Tones Example



“No” error for best S/N, 3 dB for signal at analyzer DANL

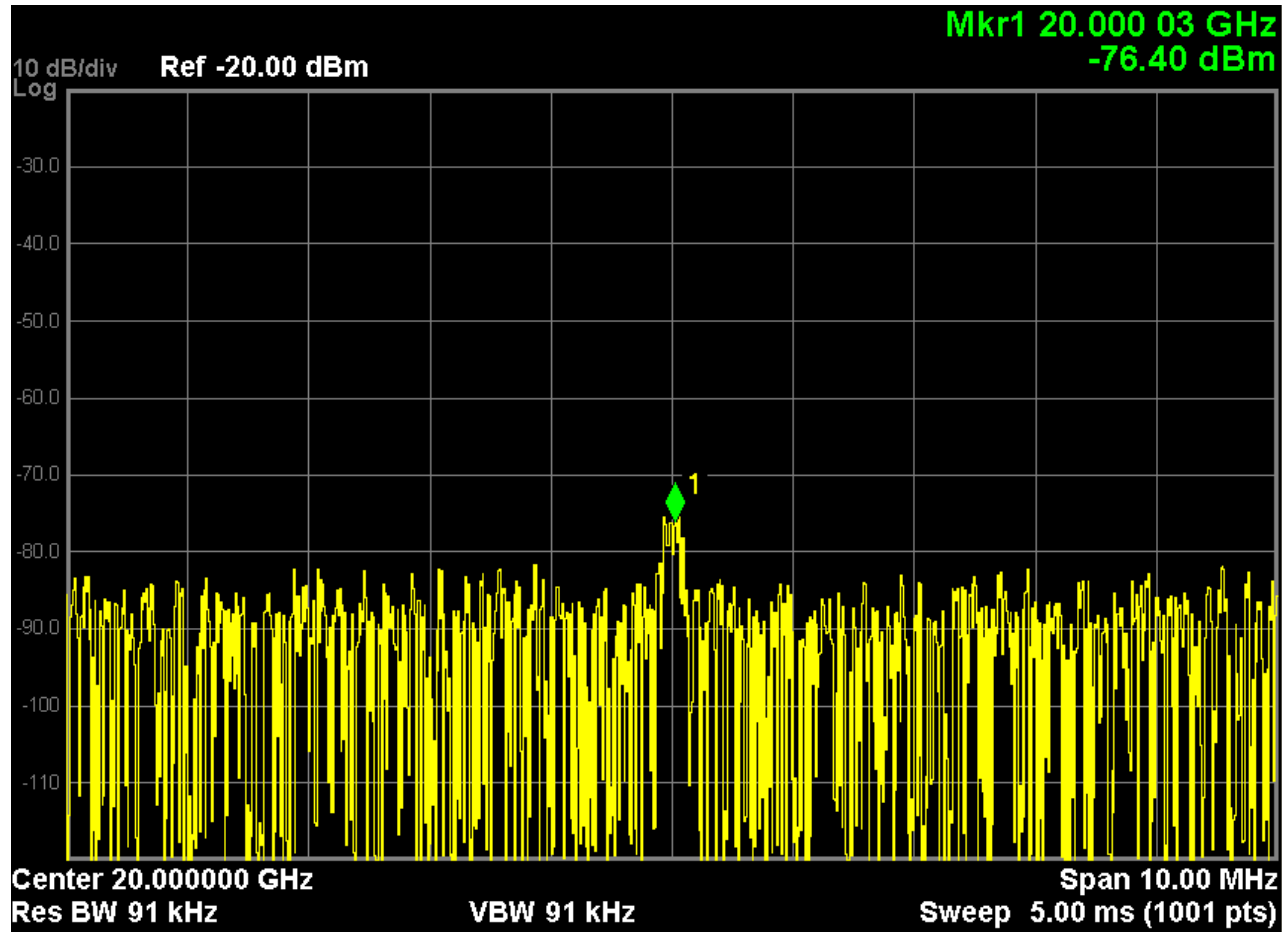
Noise Converts ~Deterministic Value to Statistical Distribution



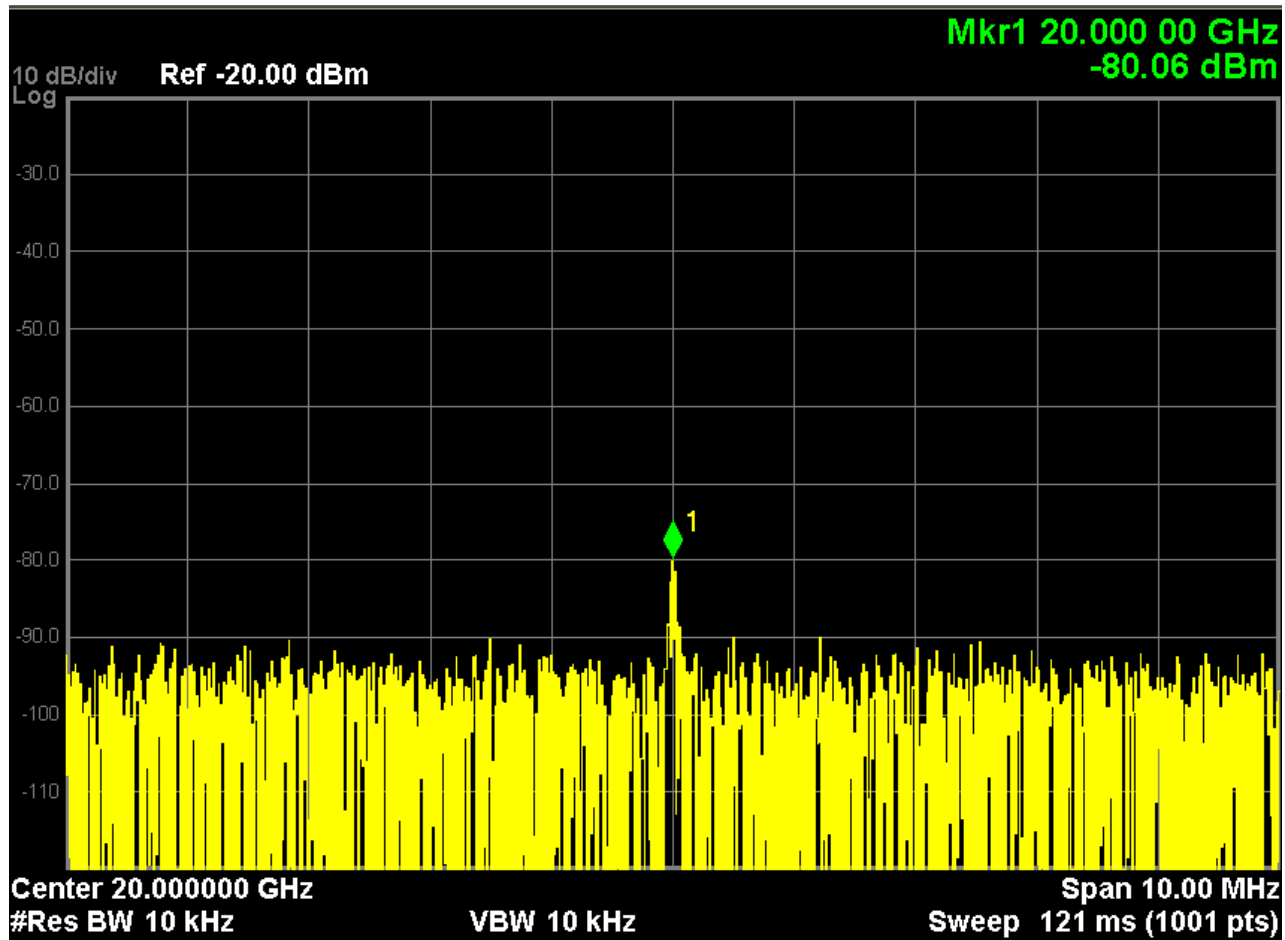
* CCDF varies significantly with span at low SNRs

Clues to Two Meas Problems

Signal Close to Noise, Wider than RBW

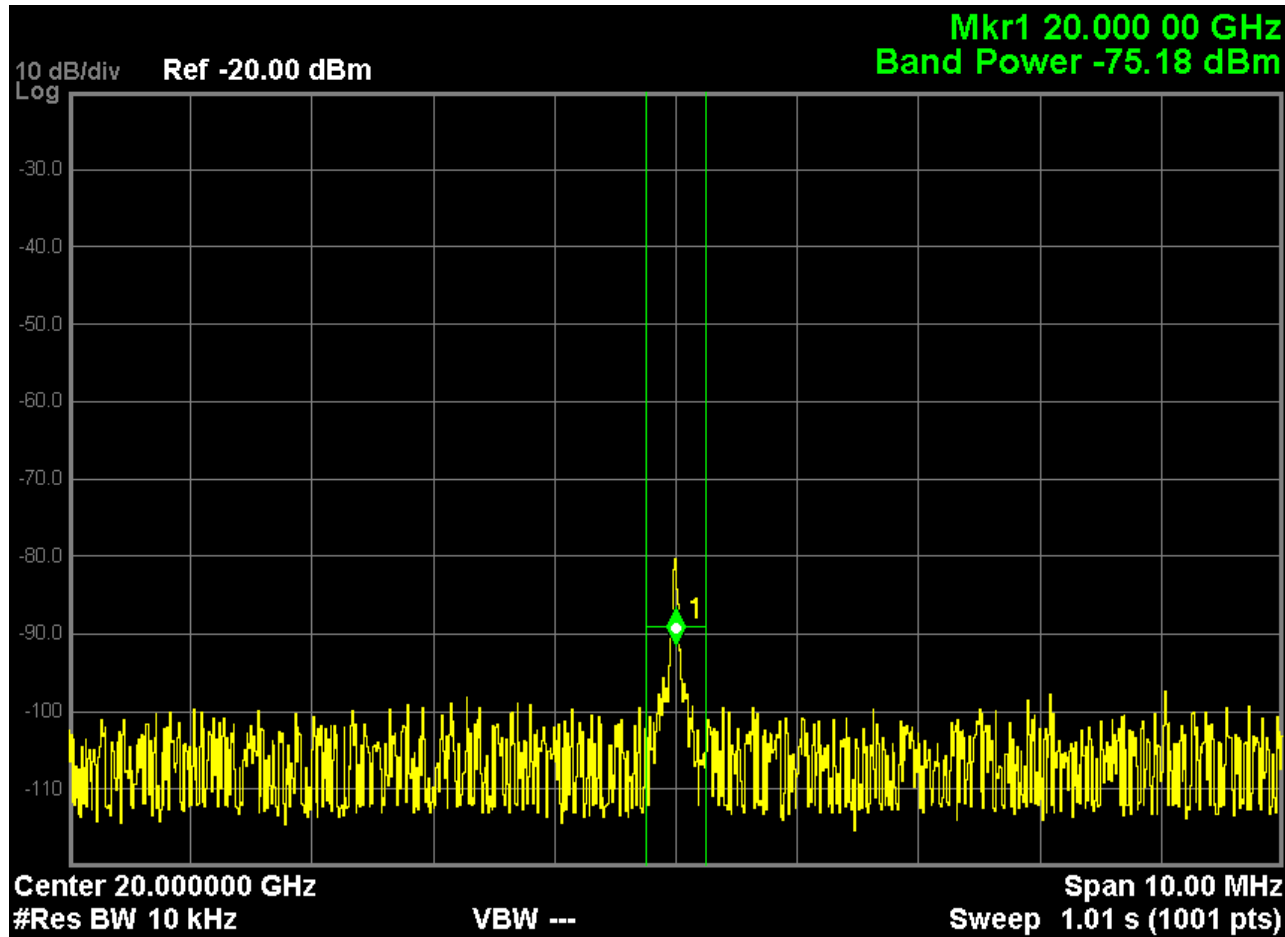


Narrower RBW Improves S/N



- Residual FM, signal is wider than RBW filter
- Amplitude measured low in error

Band Power Marker, Averaging



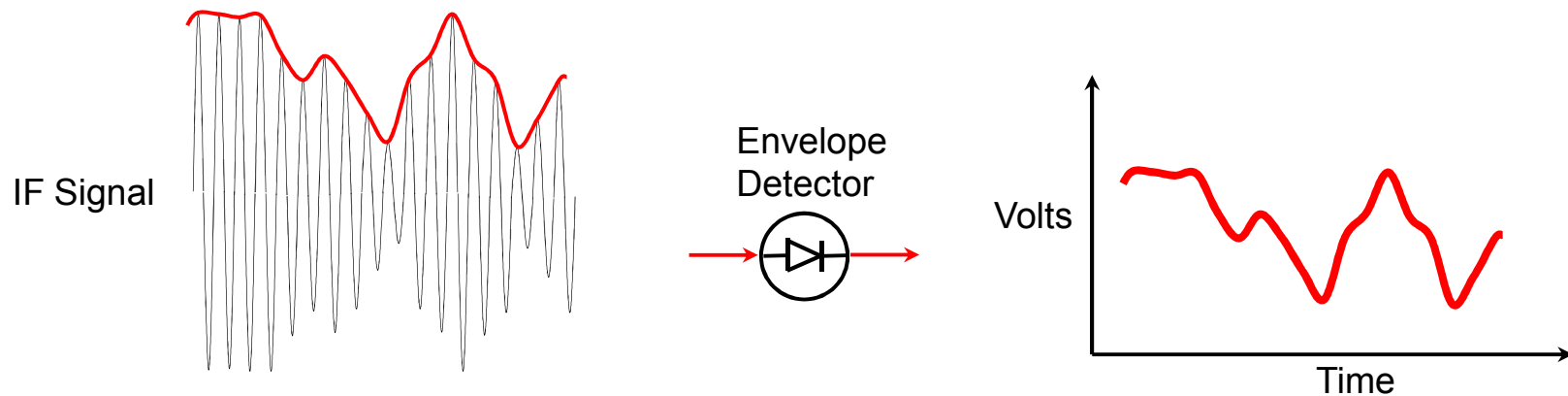
- Band power marker compensates for signal spread
- Longer sweep, average detector reduce variance

Detector Types, Averaging Scales

Understanding Enough

- Processing, Data Reduction Always Done
- Signal Characteristics Affect Results
- Basic Settings (RBW, Span, Sweep Time) Affect Results, Even With Same Detector
- Know Enough To:
 - Use your knowledge of your signal
 - Understand results, know what you are getting
 - Make good measurements
 - Identify signal problems, measurement errors

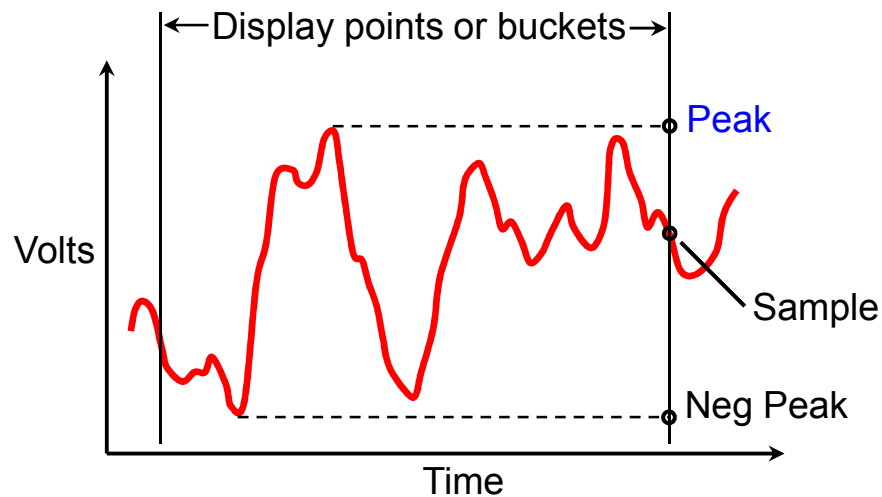
The IF Envelope Detector



- Input is the IF Signal (RBW), Output is Baseband
- Output Voltage is Proportional to Input Envelope
- Response is Different for CW Signals and Noise

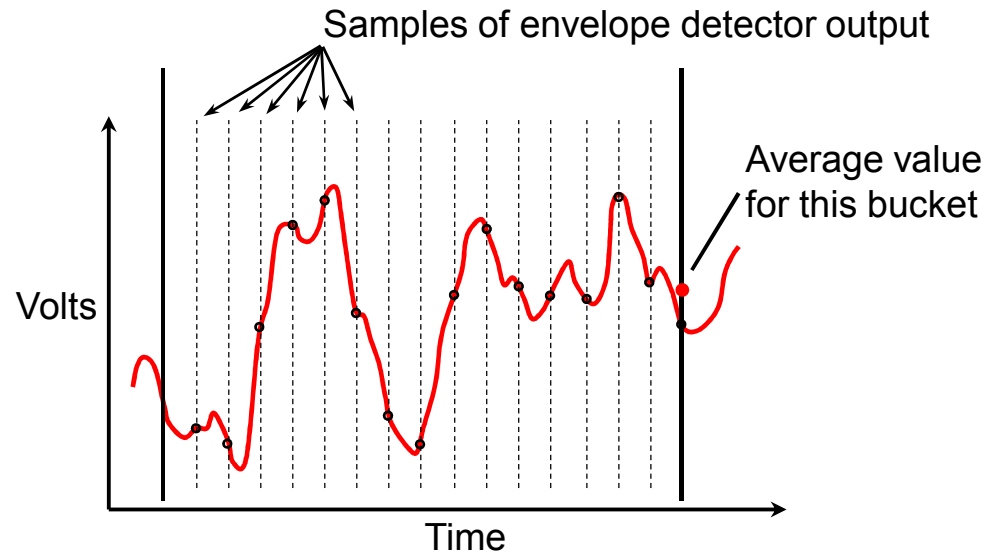
Display Detectors

Peak, Negative Peak, Sample



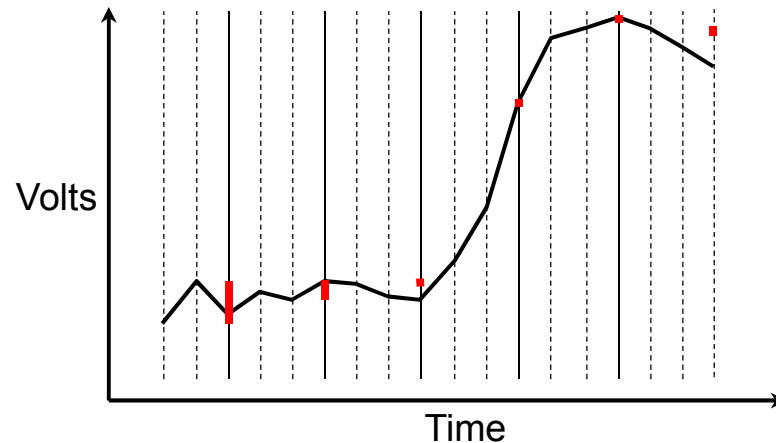
- Input is the IF Envelope Detector Output (log or linear scaled)
- Peak and Neg Peak Detectors Bias the Output Value, Perform Some Data Reduction

Averaging Detectors



- Each Output Represents 2 or More IF Envelope Values
- Reduces Variance Faster Than Single-Value Detectors;
Reduce Variance Further by Increasing Sweep Time
- Good Choice for Channel Power or ACP Measurements

Signal-and-Noise Detectors



- Better Represent Combination of Signals and Noise
- Show Distribution of Noise and Noise-Like Signals
- Show Discrete Signals as a Single Value
- More Intuitive, but not Required for Accurate Measurements

Biased & Unbiased Detectors

- Sample Detector-Unbiased
 - Data discarded, not good at reducing variance
- Average Detector-Unbiased
 - Efficient for reducing variance
- Peak, Negative Peak Detectors-Biased
 - Bias is desirable, special-purpose use
- “Normal” Detector
 - Bias depending on signals, implementation
 - Designed for combined signals and noise



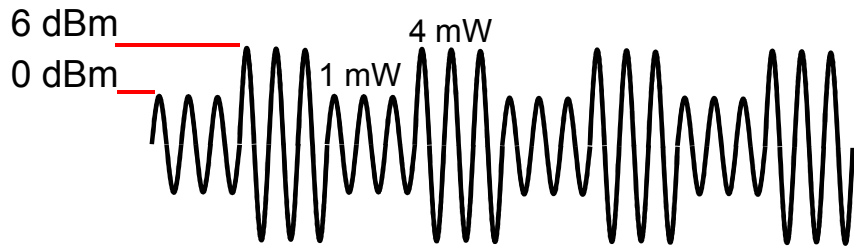
Effects of Slower Sweep Speed

- Normal Detector: Wider band of results
- Average Detector: Narrower band of results
 - Variance decreases with square root of number of **independent** samples in average
- Sample Detector: Results band unchanged
- Peak Detector: Band is narrower, higher
- Neg Peak Detector: Band is narrower, lower



Averaging Error Example

Averaging Power

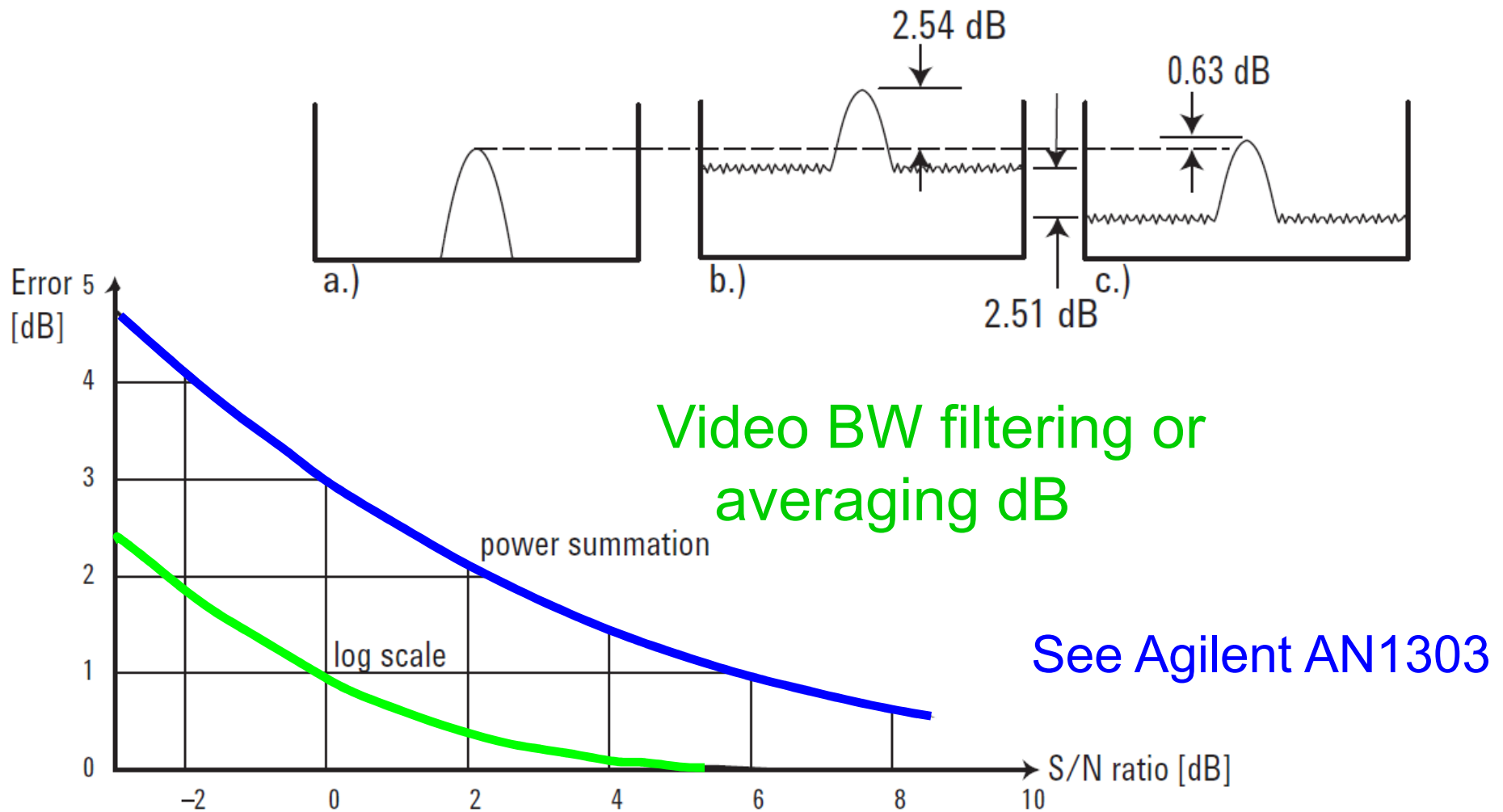


Average of the log of the power = 3 dBm
 $(0 \text{ dBm} + 6 \text{ dBm})/2$
Log of the signal's average power = 3.98 dBm
 $(1 \text{ mW} + 4 \text{ mW})/2 = 2.5 \text{ mW}$

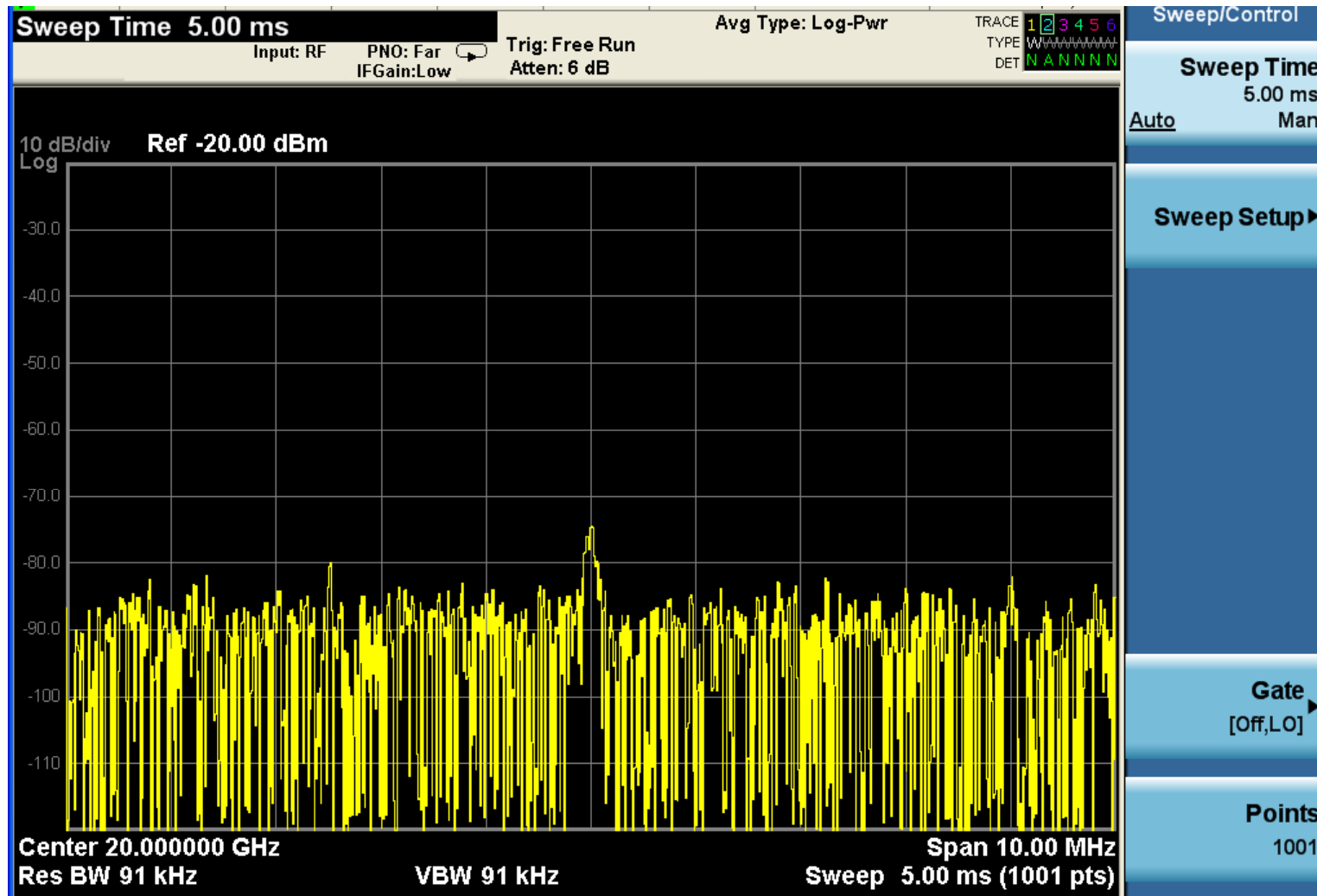
- Average of the Log is Not Equal to a Log of the Average
- Narrow VBW or Trace Averaging Performs an Average of the Log, an Error in Measuring Time-Varying Signals
- Instead, Average the Power or Report the RMS Value of the Voltage of the Signal

Log Scale Bias for CW Meas.

Log scale better for single CW signal near noise

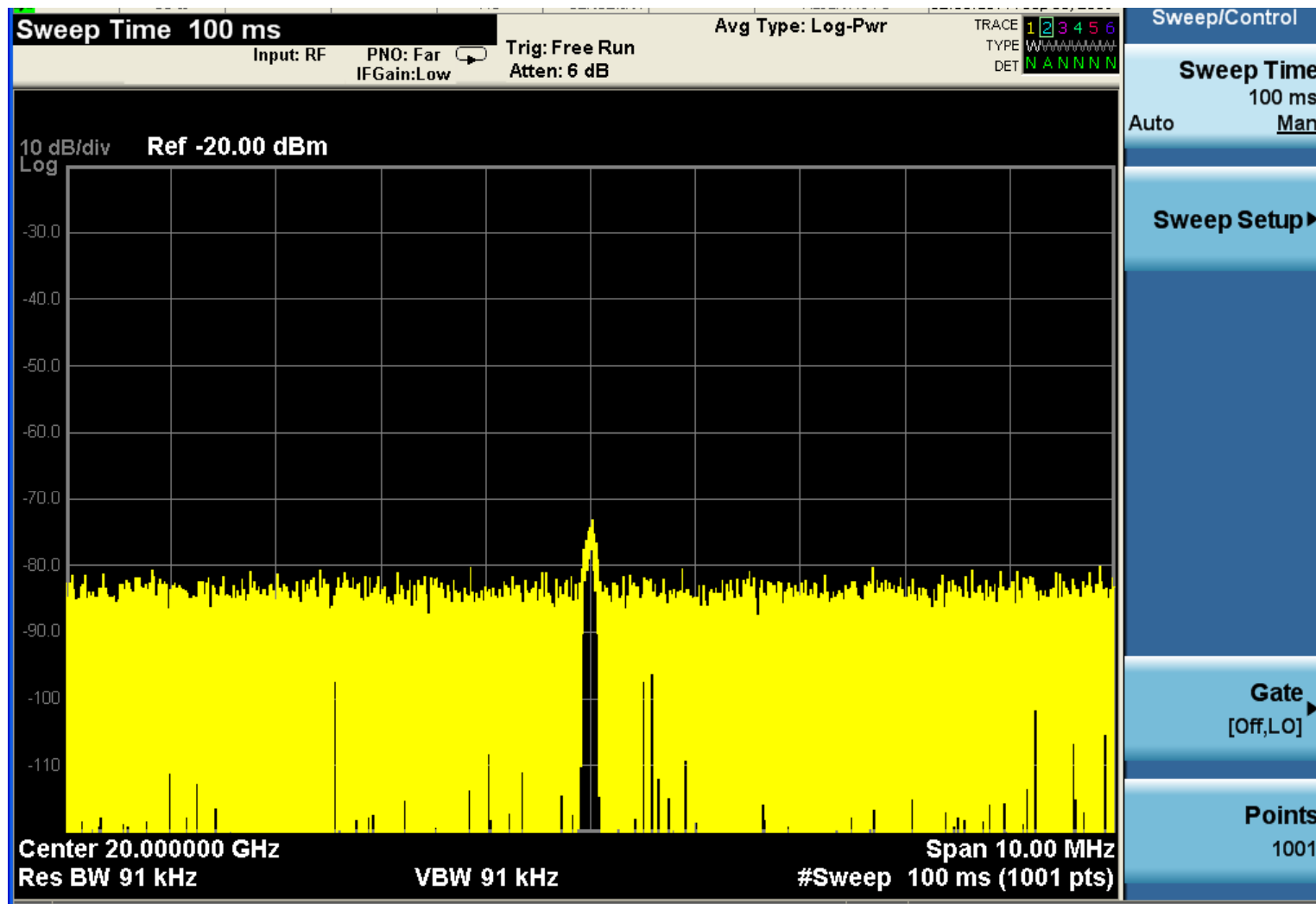


Detectors/Averaging Example



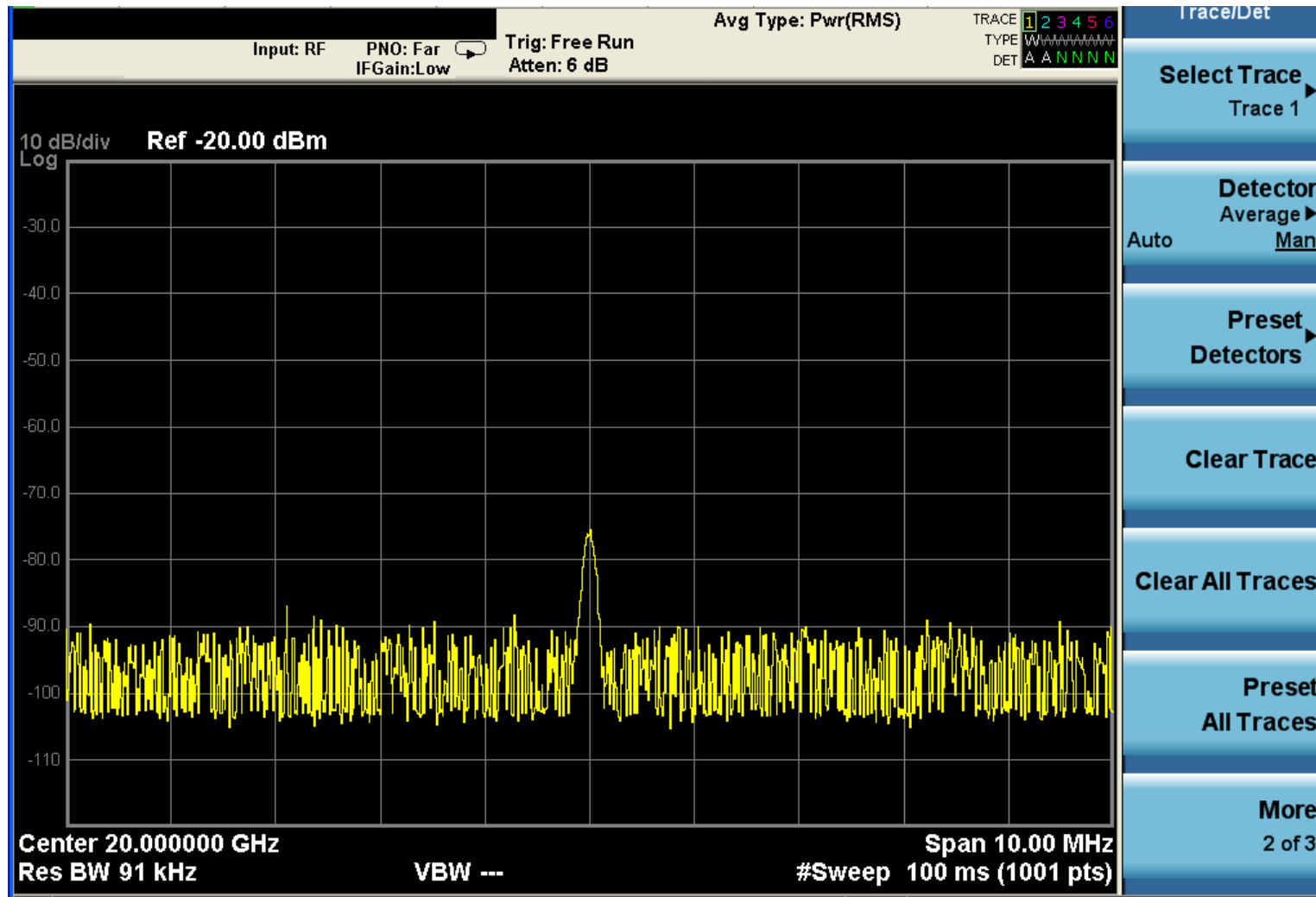
- **Default:** normal detector, log-power averaging

Detectors/Averaging Example



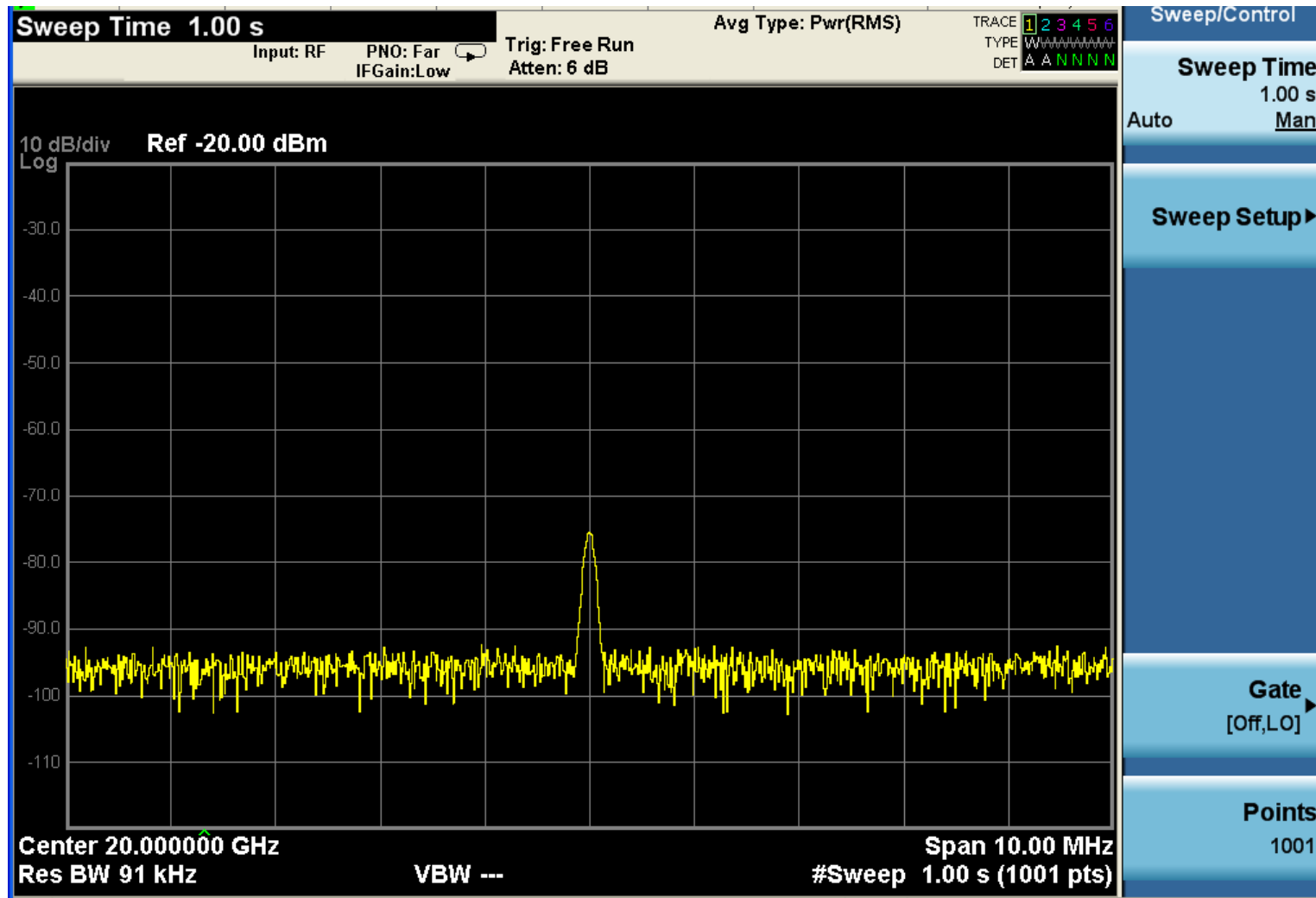
- Normal detector, log-power avg. **longer sweep**

Detectors/Averaging Example



- **Average** detector, RMS power

Detectors/Averaging Example



- Average detector, RMS power, longer sweep

Reducing Measurement Noise

- Filtering
 - RBW (not VBW or averaging)
 - Preselection
 - External
- Time or Synchronous Averaging
- Subtraction
- Best Practices



Costs of Sensitivity

- Time
 - Sweep time (narrower RBW, VBW)
 - Averaging
- Money
 - Better instruments
 - Better cables, connectors
 - Preamplifiers
 - External filtering



Traditional Approaches

- Narrower RBW
 - Reduces noise floor (ENBW)
 - May reduce measurement variance
- Video Filtering, Trace Averaging
 - Does not reduce noise floor
 - Reduces measurement variance
 - Average of log of meas, may distort results
 - Effect varies with signal statistics
- Detector Choices
 - Select for accuracy, fast reduction of variance

Traditional Approaches (cont)

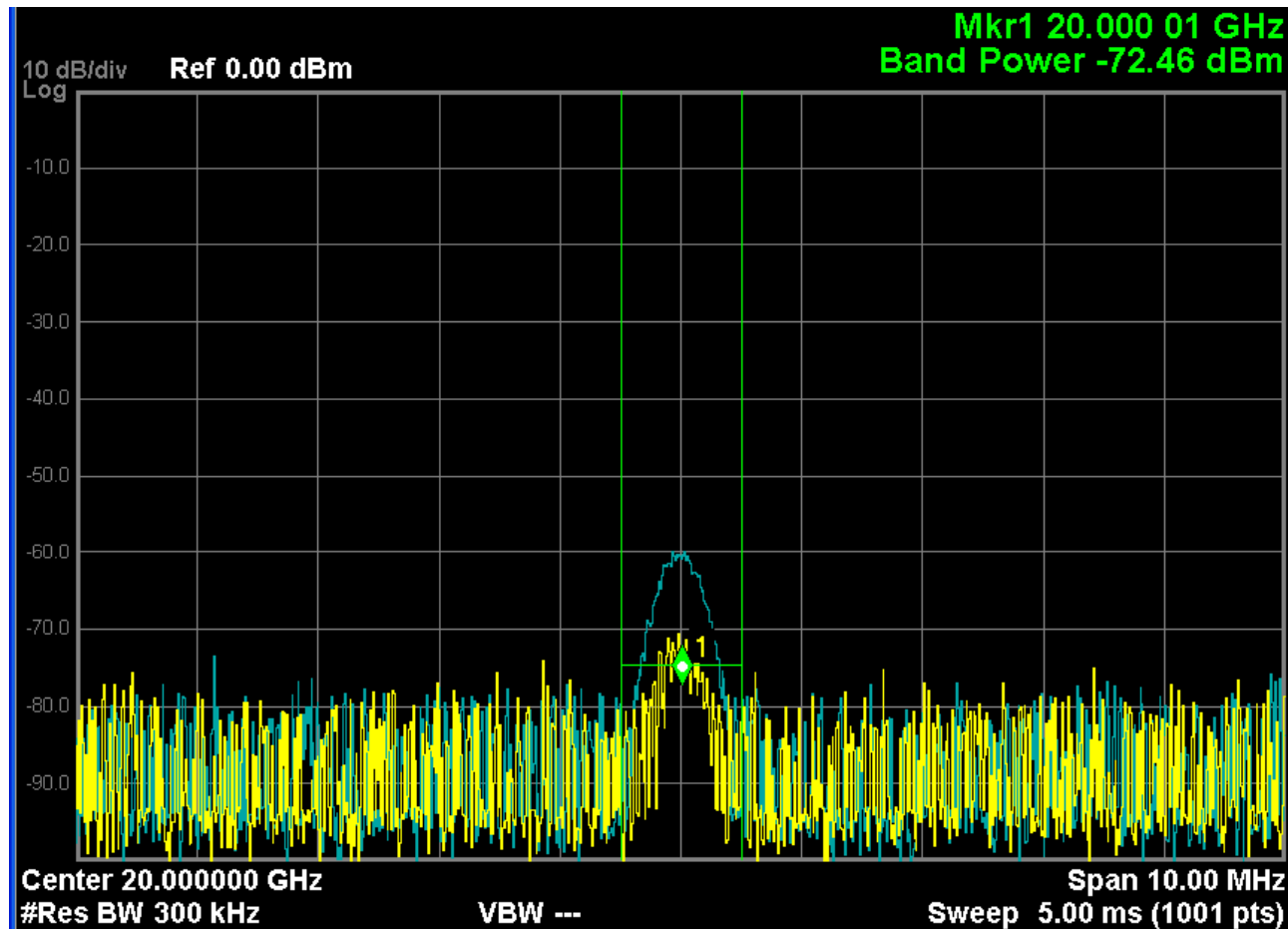
- Improve Measurement Noise Figure
 - Better connection to DUT
 - Preamplification - internal
 - Preamplification-external
 - Preselector (internal YIG-tuned filter)
 - External filtering
- Intelligent Operator Filtering
 - “If it looks good it is good” (?)
- Define Results, Objectives Better
 - Account correctly for noise effects

Cables, Connectors, Adapters

Importance Increases with Frequency

- Shortest, Best Connection to Circuit
 - Shorter cable, move analyzer or DUT
 - Choose best cable
 - Minimize adapters
 - Cable/connector hygiene
 - Periodically check cable assemblies
 - Visual inspection is not enough
- 1 dB Gained/Lost = 1 dB Noise Figure

Example: Different Cables



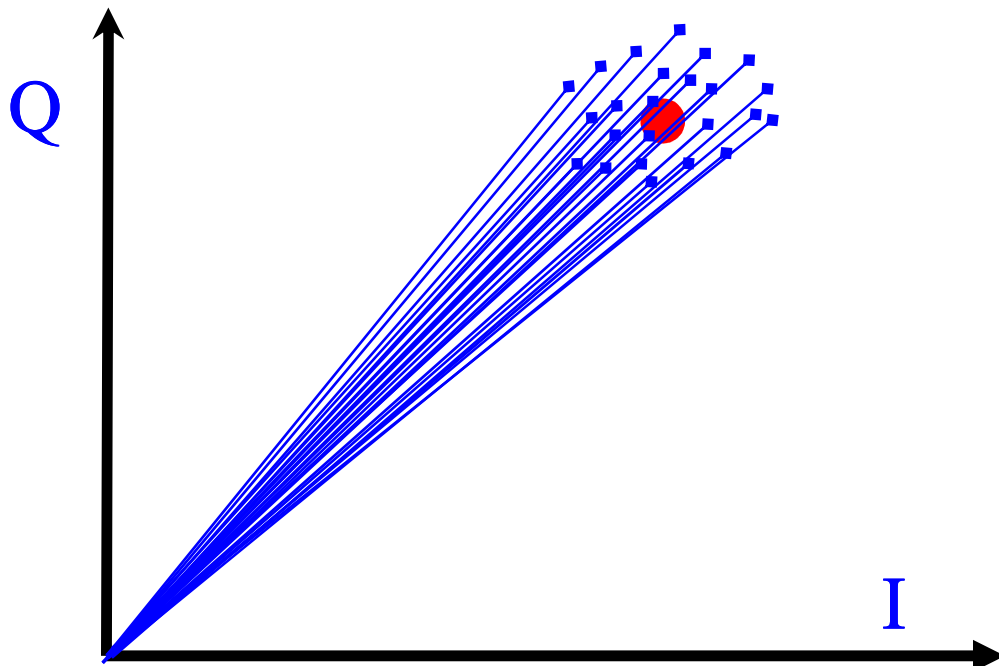
- 0.9 m and 1.6 m cables
- Clue in signal/noise ratios

Preamplifiers

- NF of Preamp must be Less than NF of Analyzer
- Benefits
 - Improved sensitivity
 - May be built-in, internally switchable
 - Gain may be included in analyzer calibration
- Drawbacks
 - Best when input is small signals only
 - May limit TOI, increase distortion
 - May have limited bandwidth
 - Calibration less convenient if external

Less-Common Approaches

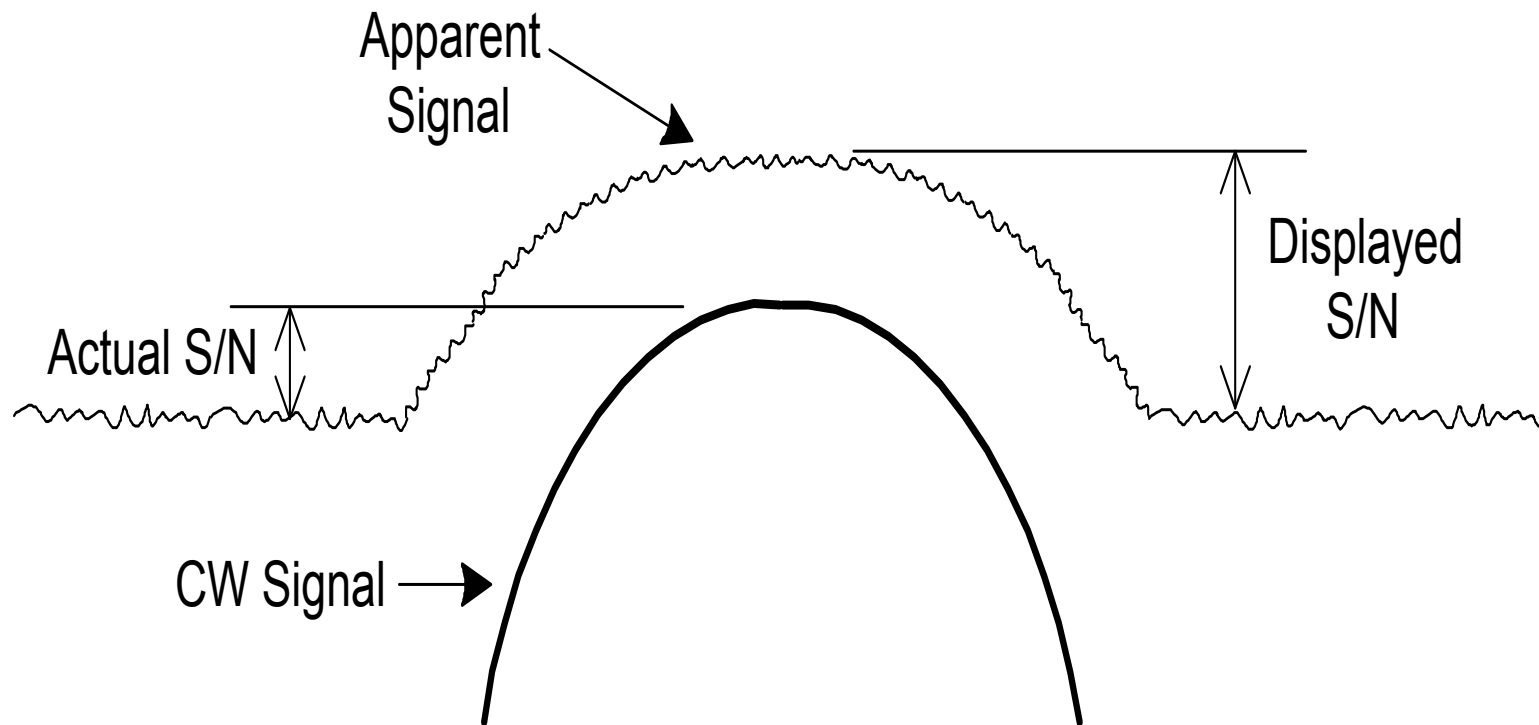
- Measure and Subtract the Noise Power
- Vector Average to Remove Noise
 - Coherent (time-triggered) averaging
 - Requires repeated signal, triggering



Vector average of repeated, synchronized measurements converges to the noiseless value



CW Signal Measured Near Analyzer Noise Floor



Amplitude & Frequency Axes Expanded

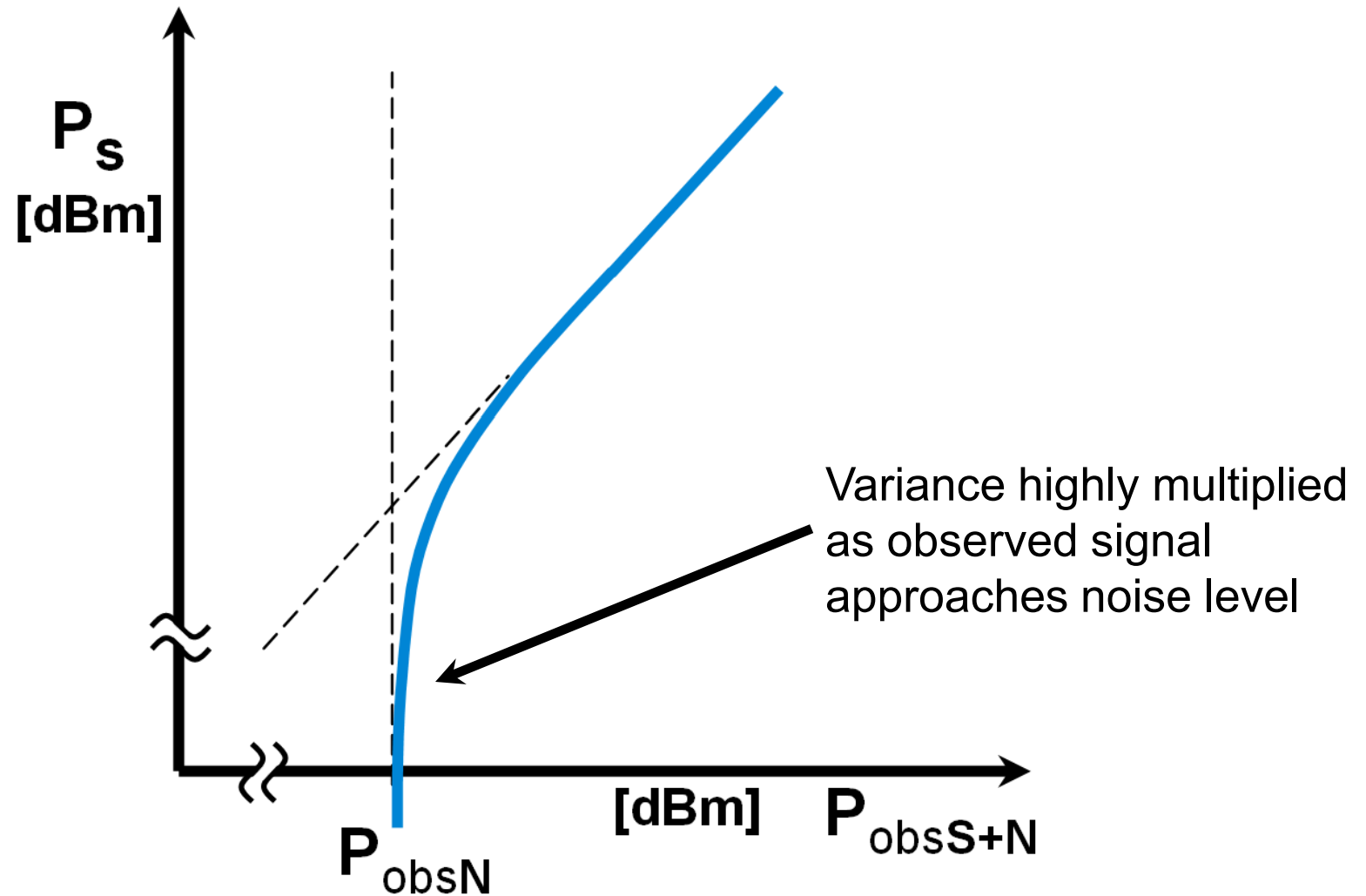
Noise Floor Subtraction

$$P_{\text{obsS+N}} = P_{\text{obsN}} + P_S$$

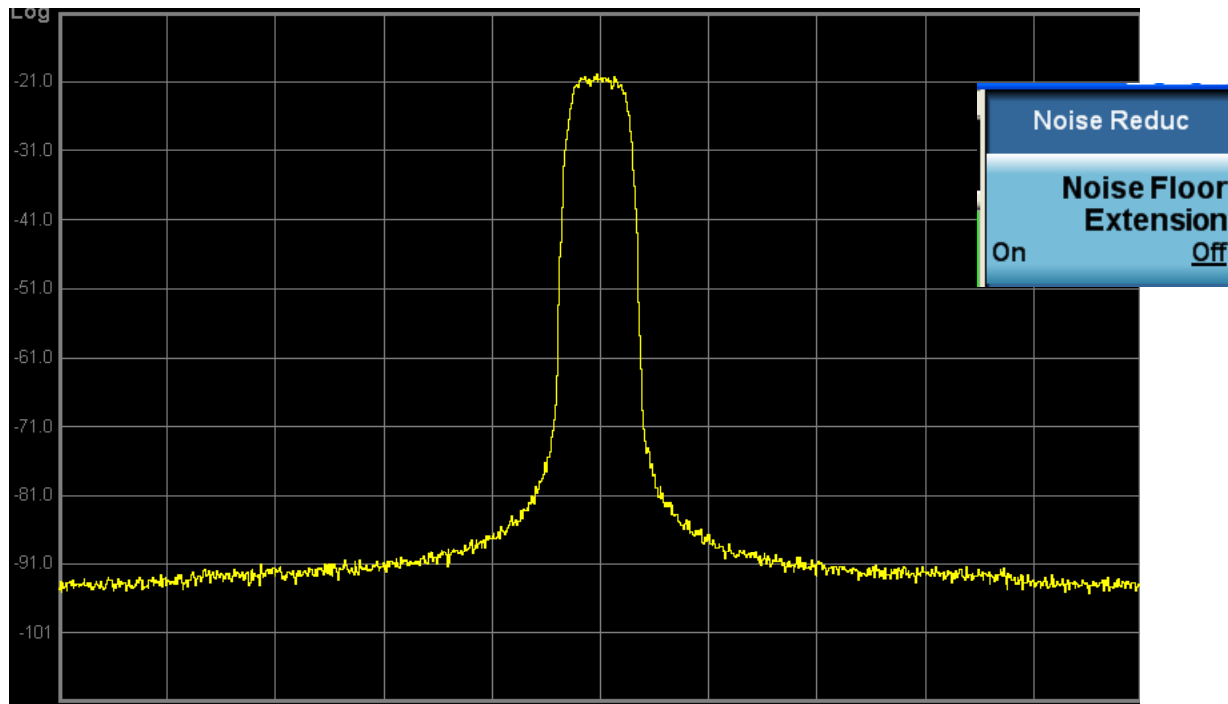
$$P_S = P_{\text{obsS+N}} - P_{\text{obsN}}$$

- Analyzer noise adds incoherently to any signal to be measured
- Power calculations are performed on a linear power scale (watts, not dBm) and results typically are shown in dBm

Plotting P_s on a dB Scale



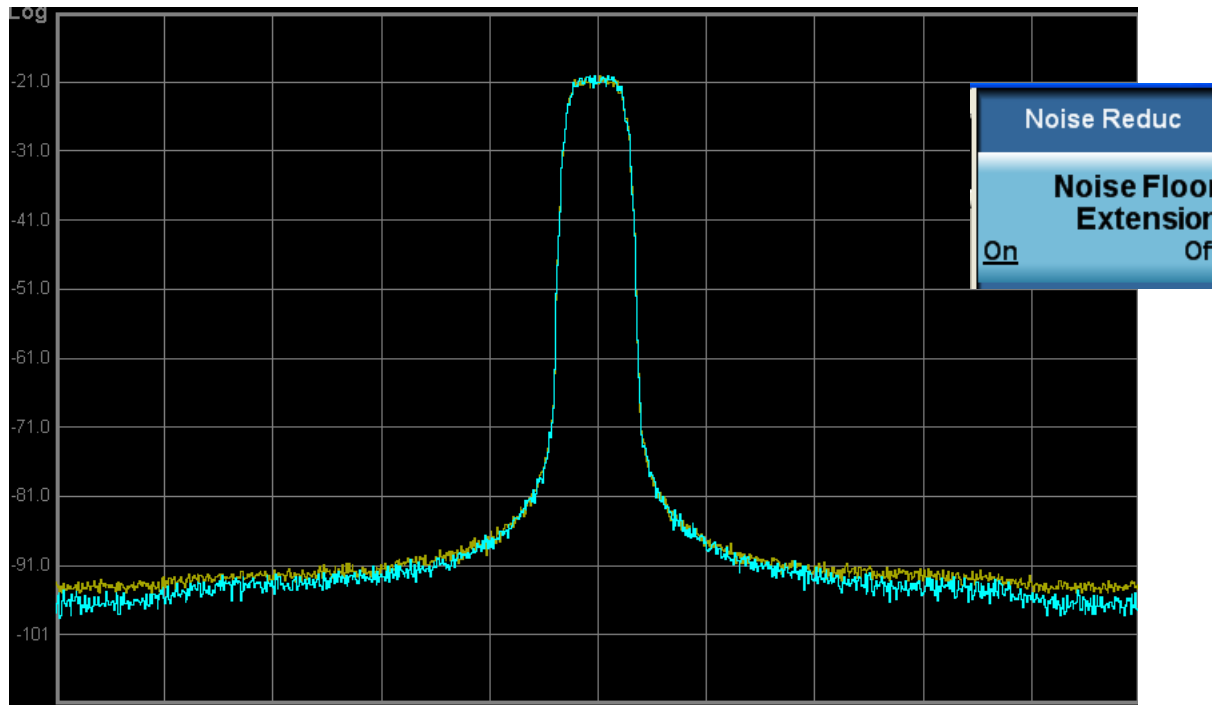
Noise-Like Signal and Noise



- 1 MSymbol/sec QPSK, 1.9 GHz
- Signal accurately measured, but noise biased higher by analyzer noise power (no NFE)
- Average detector, slower sweep to measure signal & noise, reduce variance

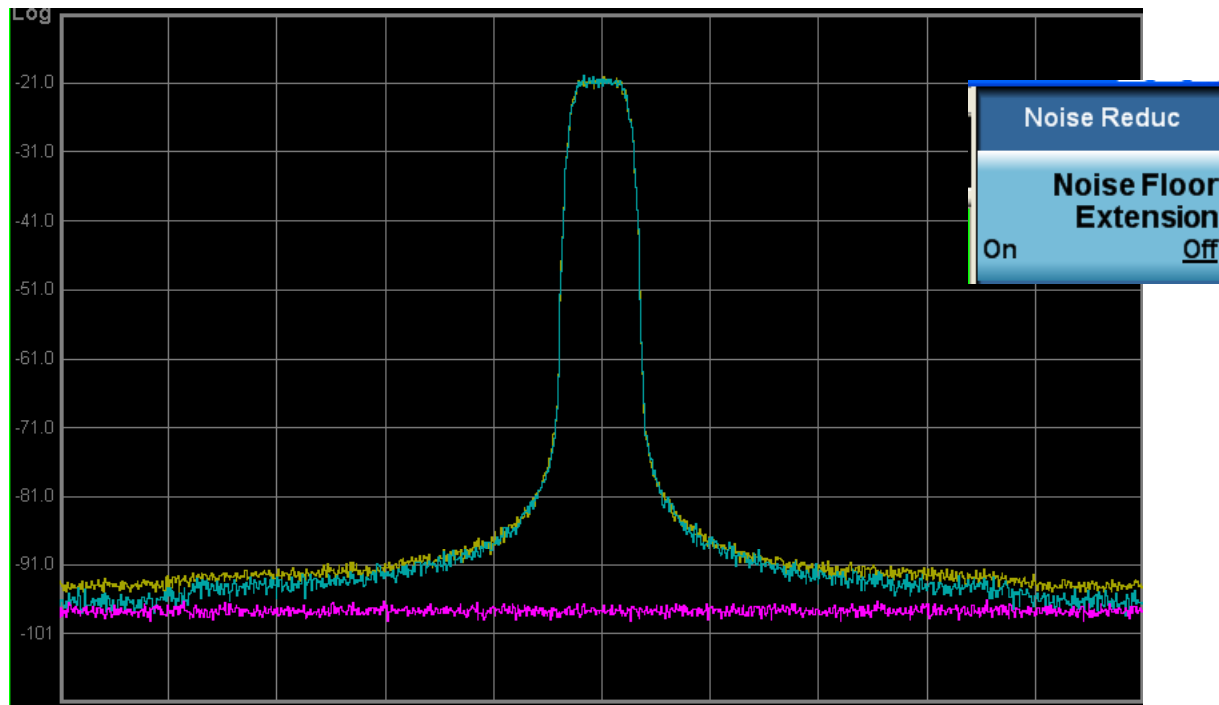
Result from Noise Subtraction

Implemented in the Agilent PXA Signal Analyzer



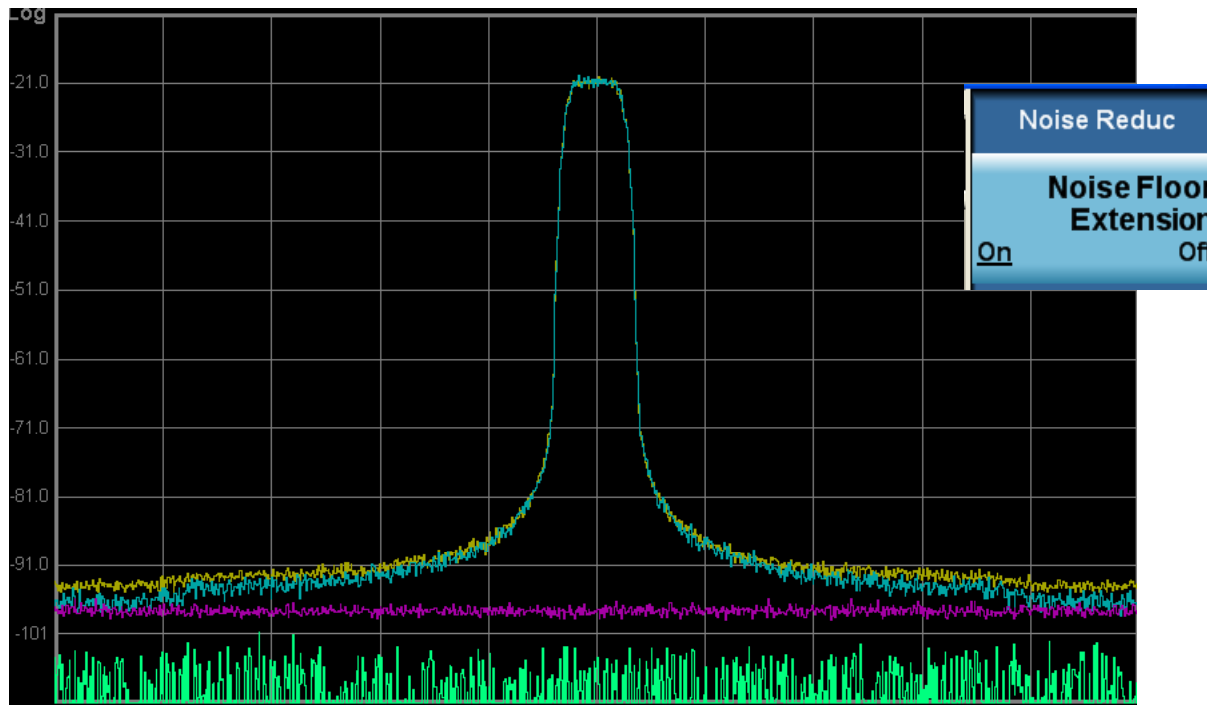
- Blue trace shows more accurate measurement due to removal of analyzer noise power
- Note increased variance of result

Analyzer Noise Floor without NFE



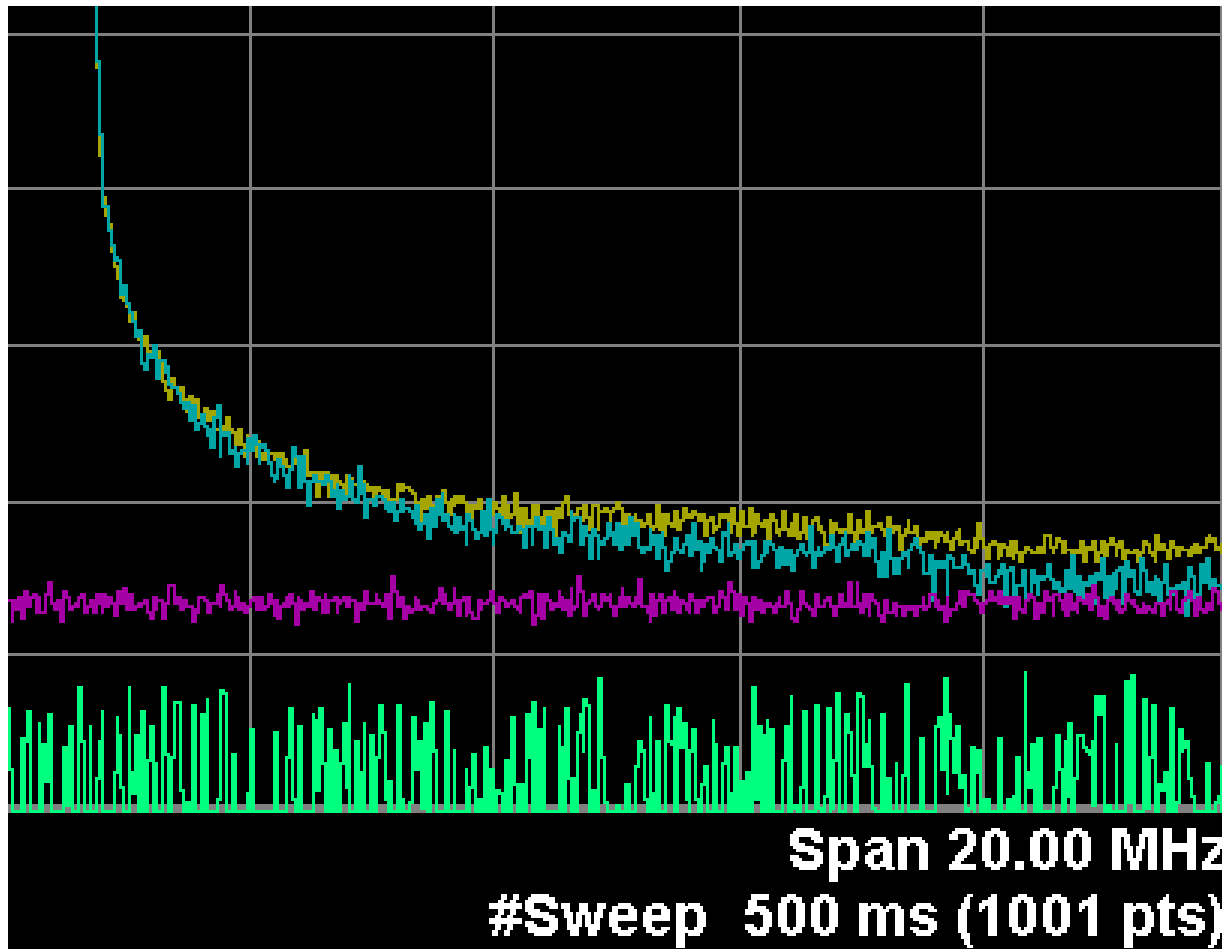
- Source switched off, pink trace shows analyzer noise level, no NFE
- Other measurement conditions unchanged
- PXA DANL (pink) adds to source power (blue) for first meas. result (yellow)
- Note that noise level variance (pink trace) is smaller without NFE

Analyzer Noise Floor with NFE



- Source still off, green trace shows analyzer noise level with NFE
- Other measurement conditions unchanged
- Note high variance result from subtraction of small, noisy numbers
- Analyzer DANL now far enough below source for minimal (0.2 - 0.4 dB) error

A Closer Look



- Pink trace adds to blue trace; result is yellow trace (NFE not used)
- Green trace is included in blue trace but resulting error very small

Noise Power Subtraction vs. Noise Cancellation or Removal

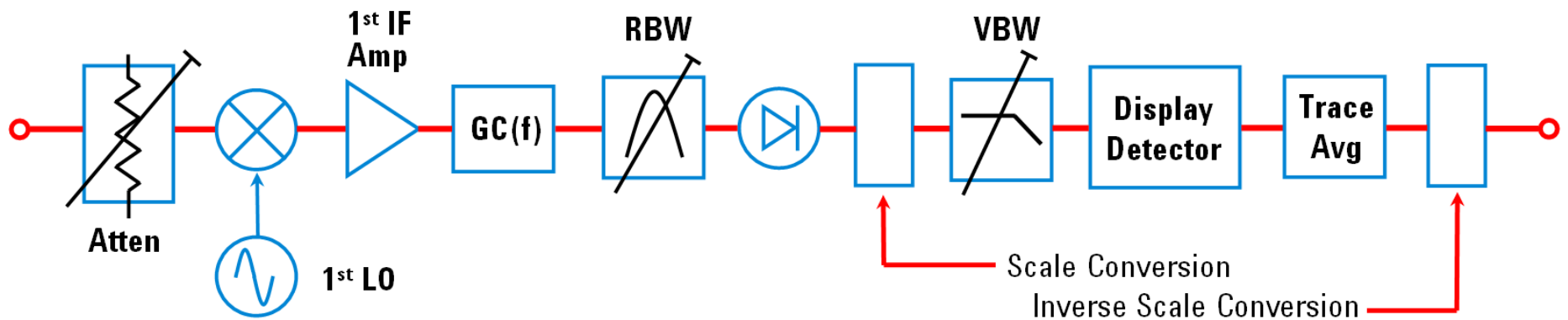
- Power Subtraction Useful for Spectrum & Power (channel power, ACPR) Meas.
- Noise Power from Phase Noise can be Removed
- Improving Demodulation (EVM, RCE, MER, all vector errors) Requires Lowering Inherent Noise or Vector Subtraction



Conditions and Requirements for Effective Noise Subtraction

- Signal and Analyzer Noise Uncorrelated
- RMS Detection (calculations simpler, more accurate)
- Extensive Averaging (to reduce signal variance)
- Averaging on Power Scale (even if results displayed on a log scale)
- Need
 - Method to remove input signal & measure noise
 - or–
 - Prior knowledge of analyzer noise floor under all measurement conditions

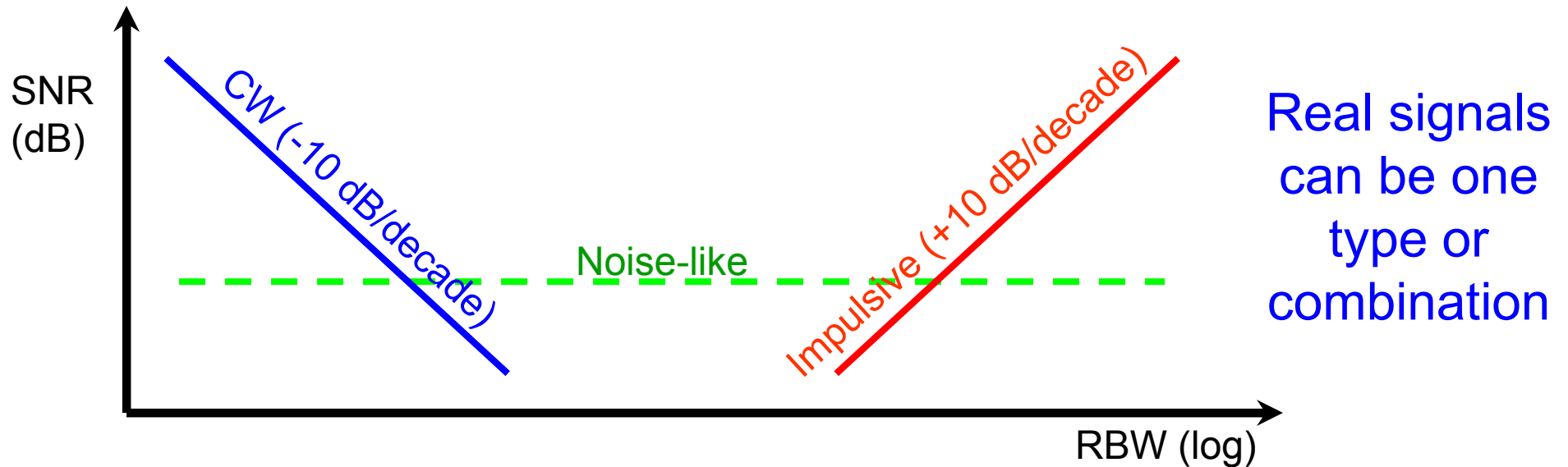
Signal Analyzer Low-Band



- Noise Contribution of Analyzer Elements must be Measured and/or Accurately Modeled for all Operating Settings

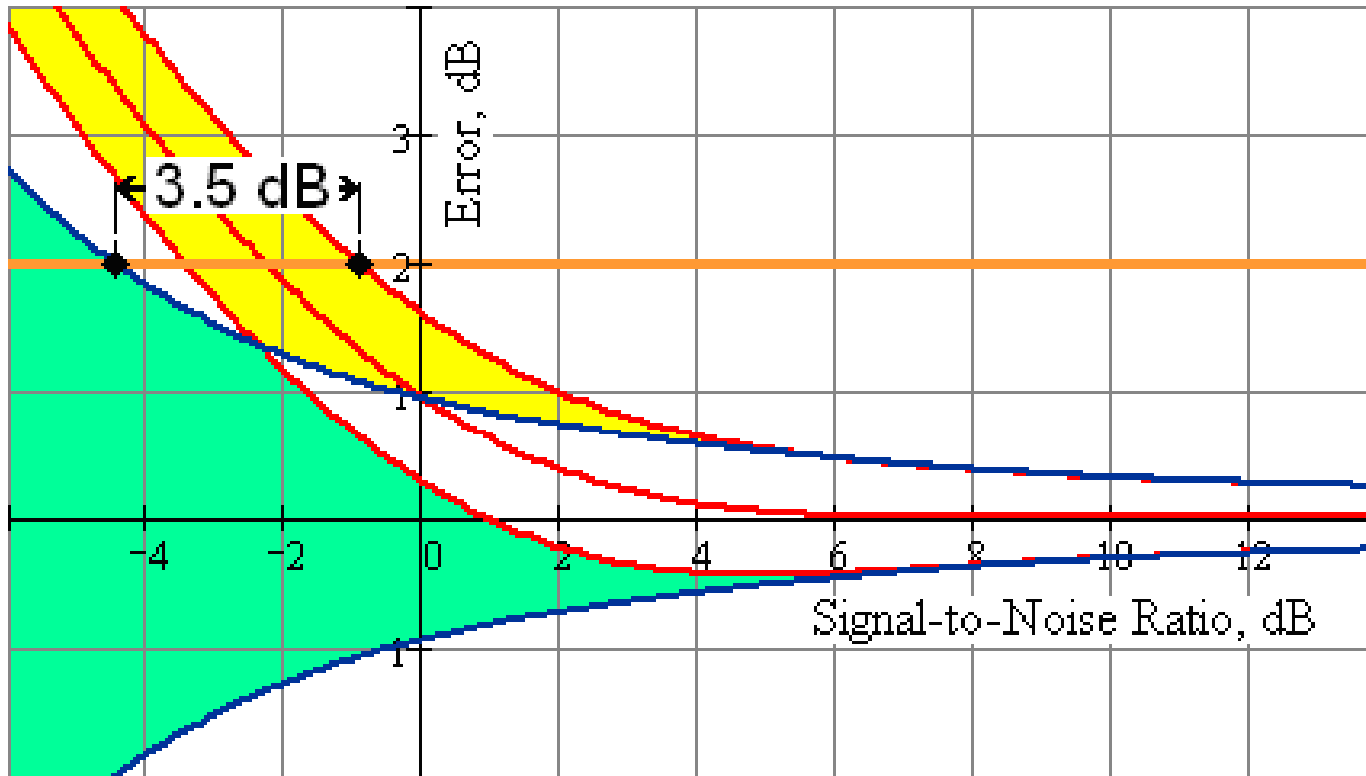
Signal Type vs. Effectiveness

Signal/Noise Variation with RBW



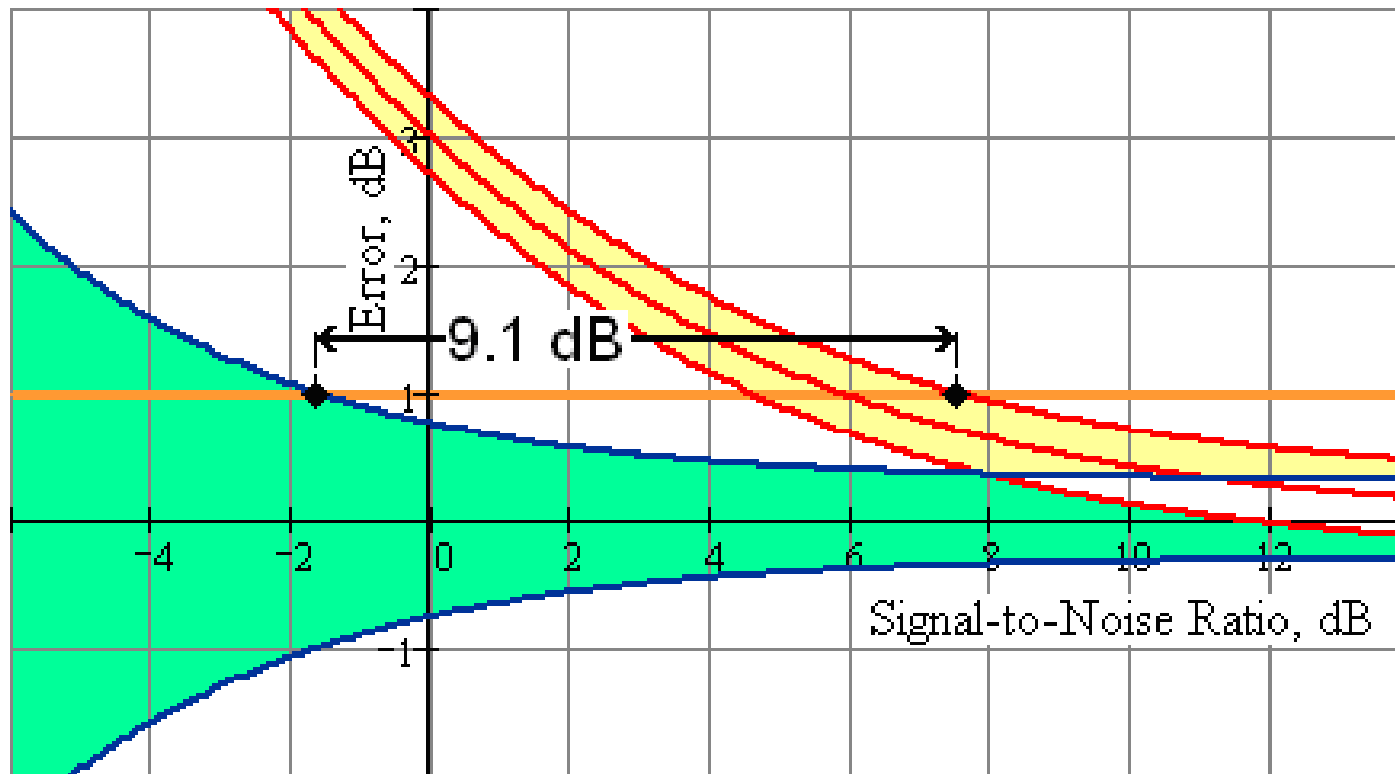
- Amplitude envelope vs. time
- Best RBW is one matched to signal
- Best ability to separate analyzer noise from signal

Noise Floor Enhancement CW Example



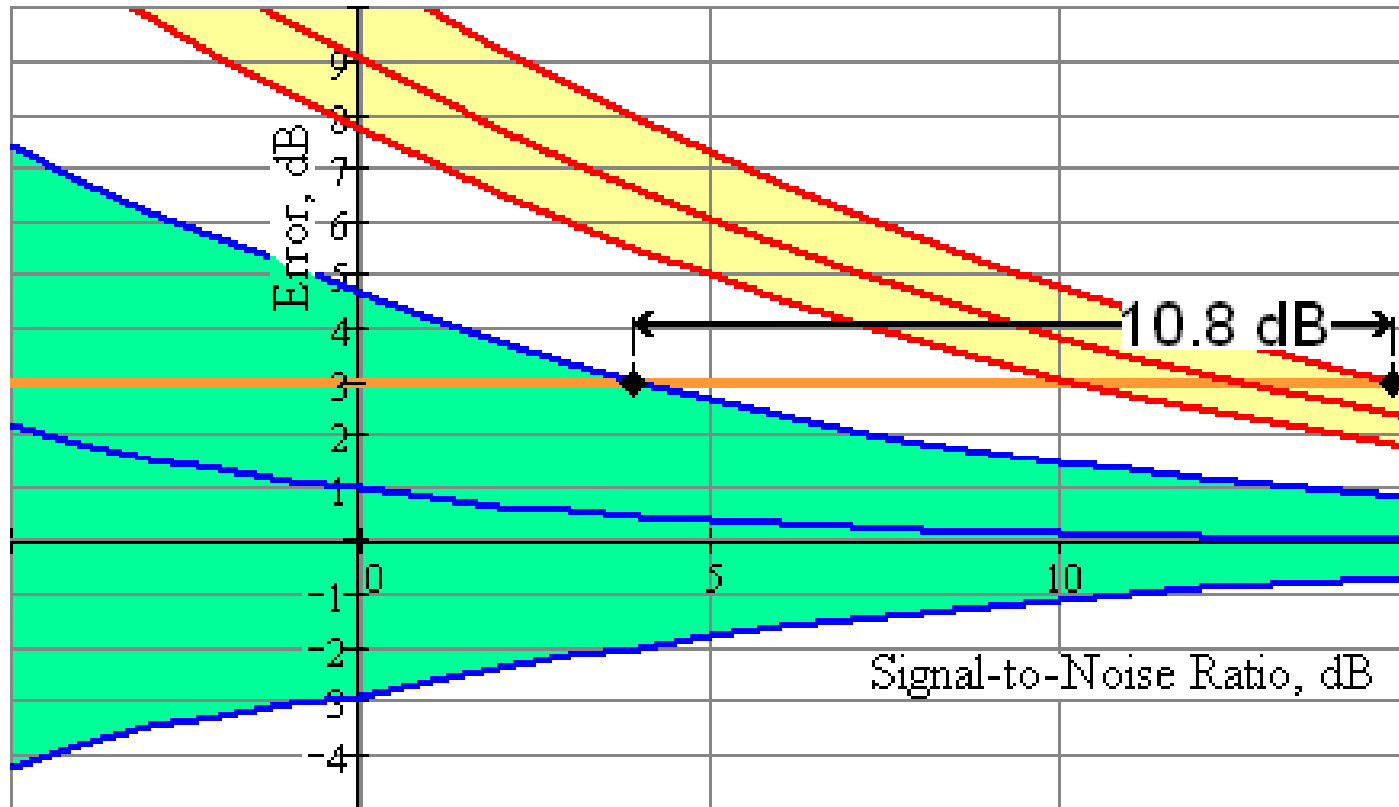
- 95% confidence interval, ± 2 dB tolerance
- 3.5 dB improvement for CW signal

Noise Floor Enhancement Noise-Like Signal Example



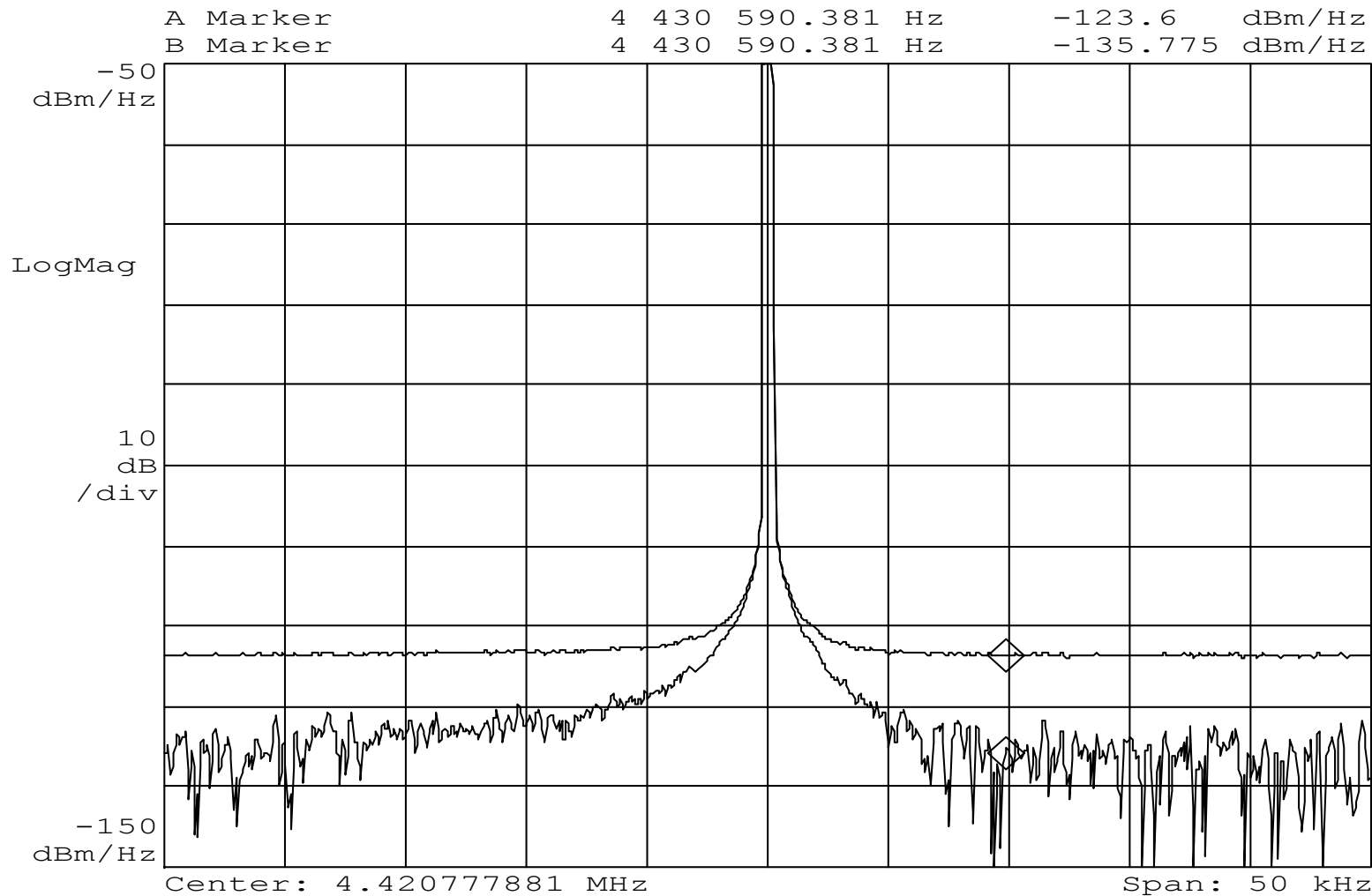
- 95% confidence interval, ± 1 dB tolerance
- 9.1 dB improvement for noise-like signal

Noise Floor Enhancement Pulsed RF Example



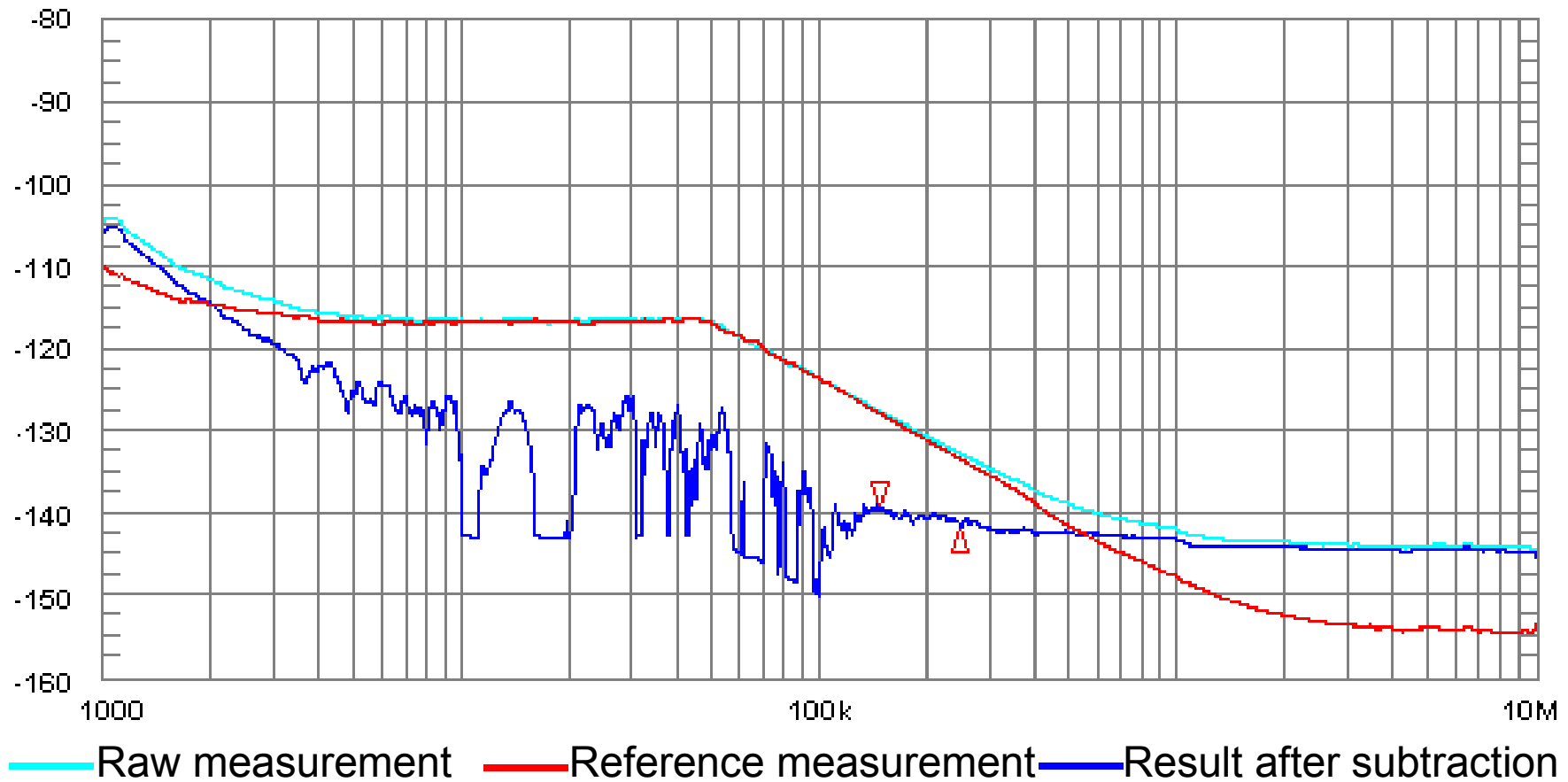
- 95% confidence interval, ± 3 dB tolerance
- 10.8 dB improvement for pulsed-RF signal

Subtracting Broadband Noise in a Phase Noise Measurement



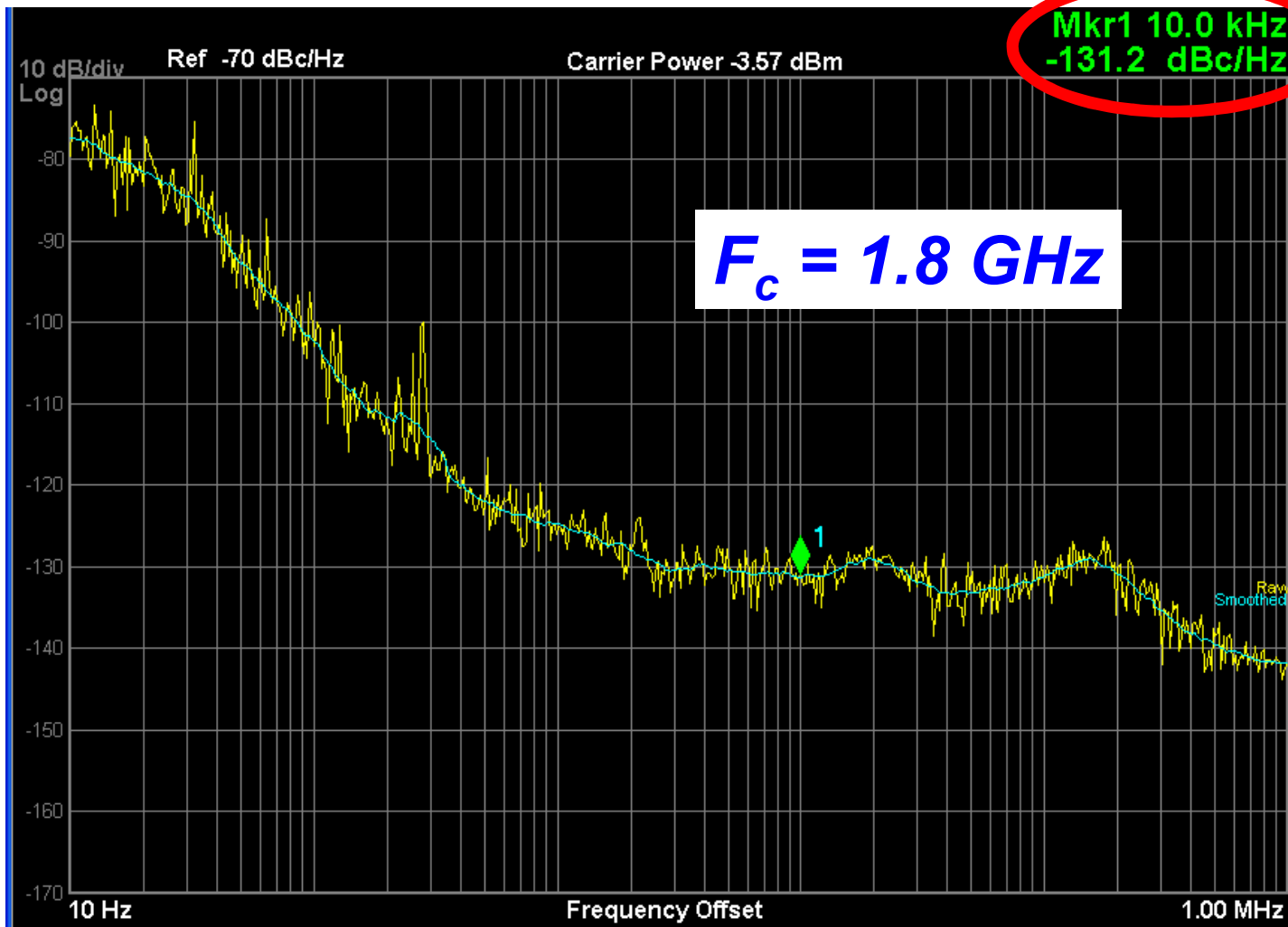
Subtracting Analyzer Phase Noise

Using Very Clean Source as Phase Noise Power Reference



Noise Subtraction Calculations Increase Variance of the Result

Better Reference Oscillator and/or Higher Performance Analyzer

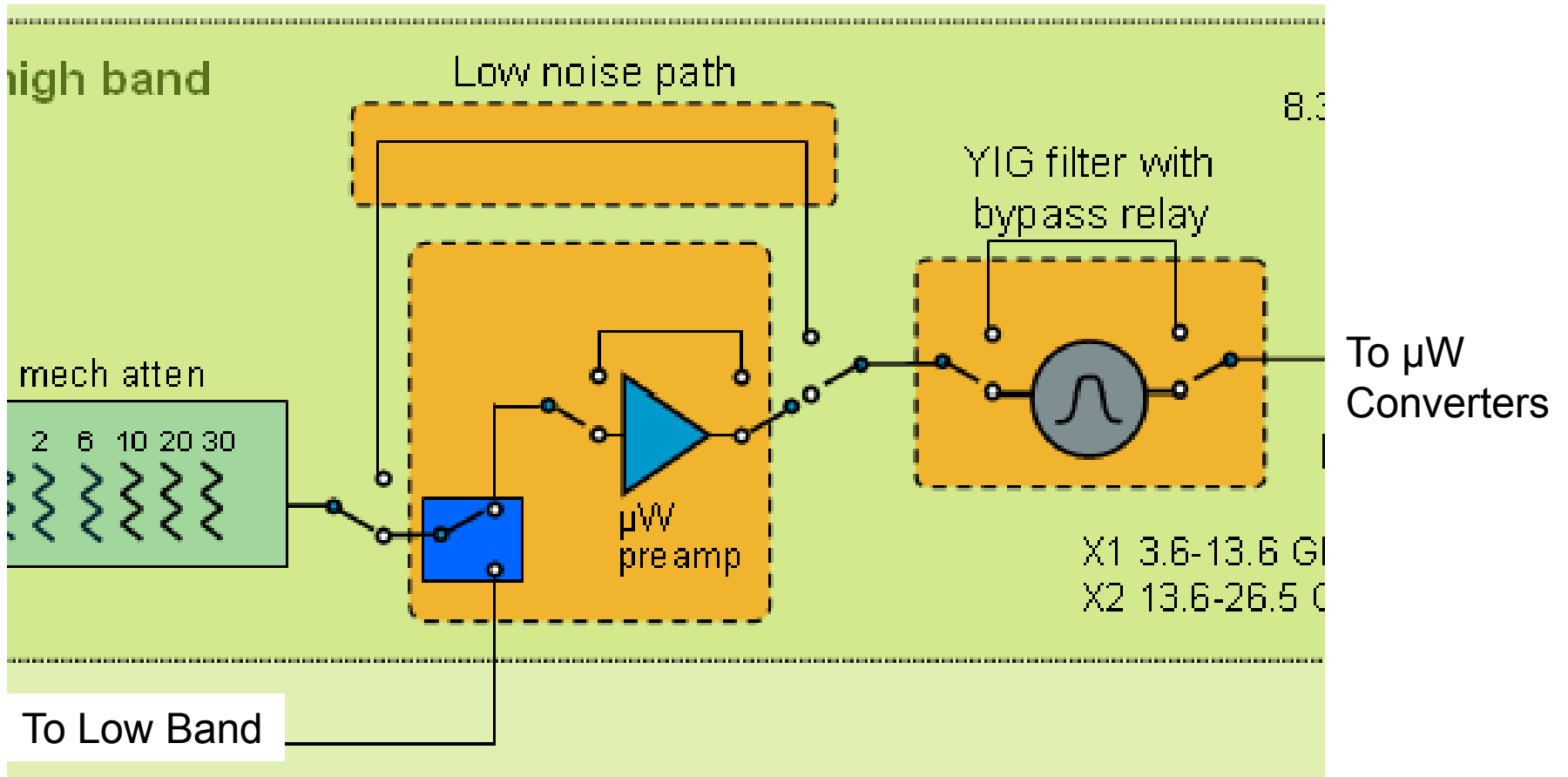


Microwave or High Band Architecture Tradeoffs

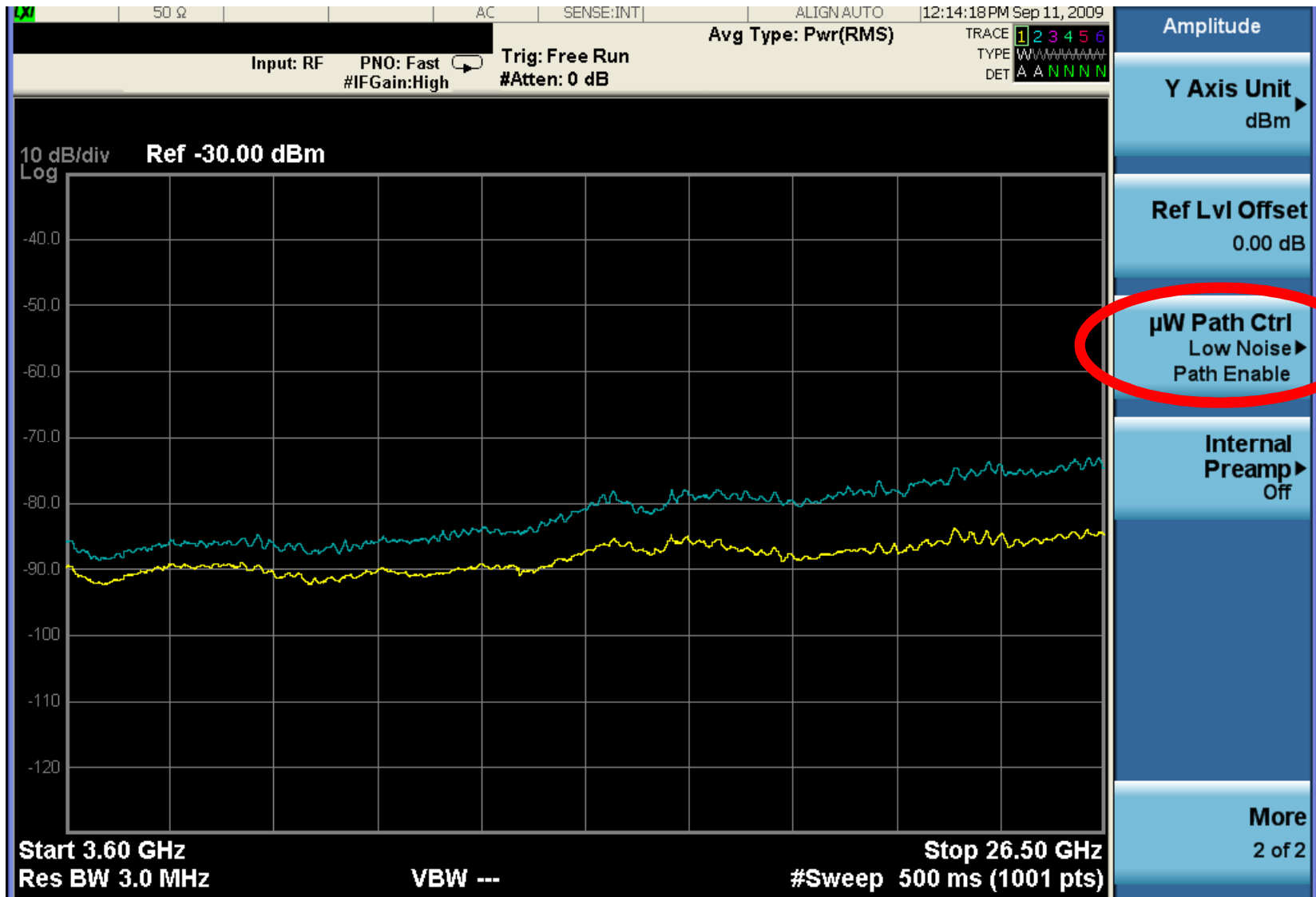
- Microwave or High Band Section
 - Path switching for low band
 - Path switching for microwave preamplifier
 - Other switching or path losses
- Alternate “Low Noise Path”
 - Optimized for high band
 - No microwave preamplifier



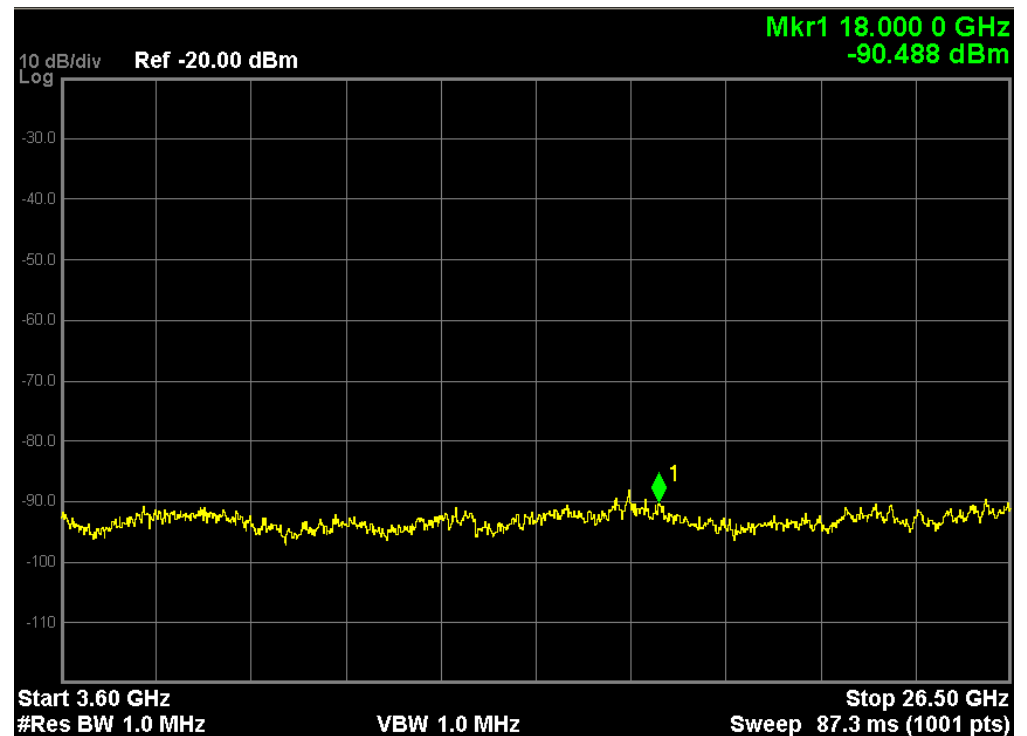
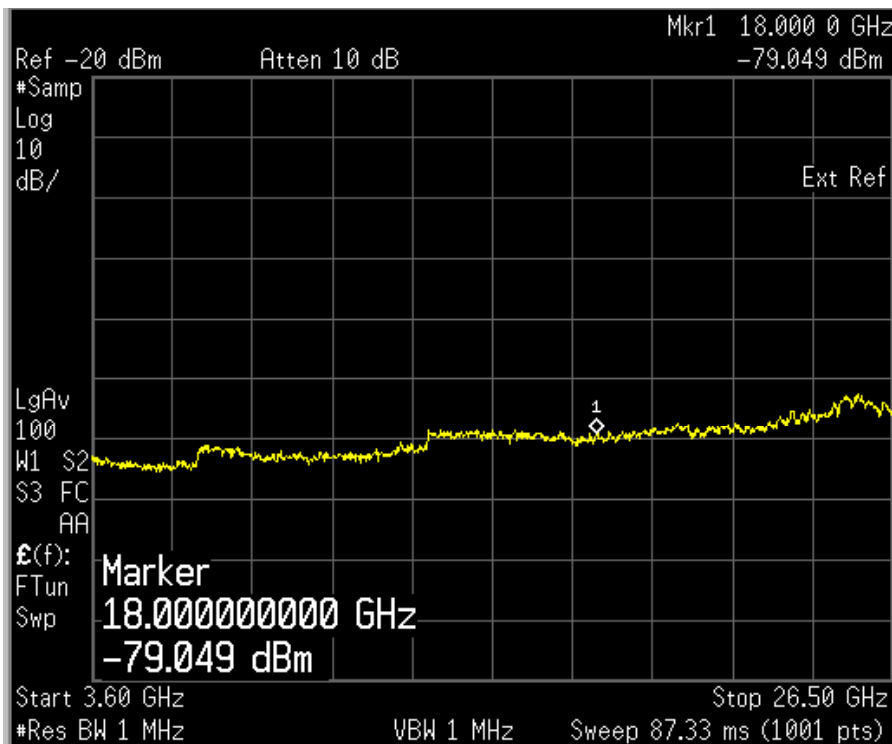
Low Noise Path



Alternate “Low Noise Path”



Combining Noise Floor Extension and Low Noise Path



- 3.6 - 26.5 GHz, preamplifier off
- Low noise path incompatible with preamp

Resources

- “Noise Floor Extension: Improving the Dynamic Range of Spectrum Analysis” Joe Gorin (to be published soon)
- “Improving the Dynamic Range of Spectrum Measurements by Compensating for the Effects of Phase Noise and Thermal Noise” Wing Mar & Ben Zarlingo, EuMW 2001
- “Spectrum Analyzer Detectors & Averaging for Wireless Measurements” Joe Gorin & Ben Zarlingo http://www.agilent.com/cm/wireless/pdf/detector_averaging.pdf
- “Spectrum Analyzer Measurements and Noise” Joe Gorin, Agilent Technologies Application Note 1303, literature number 5966-4008E
- “Spectrum & Network Measurements” Robert Witte, Noble Publishing 2001 ISBN 978-1884932168
- “Optimizing RF and Microwave Spectrum Analyzer Dynamic Range” Agilent application note AN-1315 literature number 5968-4545E
- “Electronic Test Instruments: Analog and Digital Measurements” Robert Witte, 2002 Prentice Hall ISBN 978-0130668301
- “The Art of Measurement: Theory and Practice” Ronald Potter, 1999 Prentice Hall ISBN 978-0130261748
- “Spectrum Analysis Basics” Agilent application note AN-150 literature number 5952-0292EN
- “Accurate Measurement of Signals Close to the Noise Floor of a Spectrum Analyzer” Andrew Mouthrup and Michael Muha, IEEE Transactions on Microwave Theory and Techniques, Vol. 39, No. 11, November 1991, pg. 1882 – 1885.

